

## EMC TEST REPORT

For

Fulton Science and Technology Lighting Co., Ltd

LED TRI-PROOF LIGHT

Test Model: FLT-TPT-40L15

Additional Models : FLT-TPT-10L6, FLT-TPT-15L6,

FLT-TPT-20L6, FLT-TPT-20L12, FLT-TPT-30L12,

FLT-TPT-40L12, FLT-TPT-30L15

Prepared for : Fulton Science and Technology Lighting Co., Ltd  
Address : 7F, Building 17, Area C, Liantang Industrial Town, Shangcun  
Community, Gongming Town, Guangming New District,  
Shenzhen, Guangdong Province, China.

Prepared by : Shenzhen Southern LCS Compliance Testing Laboratory Ltd.  
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Date of receipt of test sample : September 26, 2019  
Number of tested samples : 1  
Serial number : Prototype  
Date of Test : September 26, 2019 ~ December 14, 2019  
Date of Report : December 14, 2019



**EMC TEST REPORT**  
**EN 55015: 2013+A1: 2015**

Limits and methods of measurement of radio disturbance characteristics of electrical lighting and similar equipment

**EN 61547: 2009**

Equipment for general lighting purposes - EMC immunity requirements

**Report Reference No** ..... : **LCS190910040BE**

**Date Of Issue** ..... : December 14, 2019

**Testing Laboratory Name**..... : **Shenzhen Southern LCS Compliance Testing Laboratory Ltd.**

**Address** ..... : 101-201, No.39 Building, Xialang Industrial Zone, Heshuikou Community, Matian Street, Guangming District, Shenzhen, China

**Testing Location/ Procedure** ... : Full application of Harmonised standards ☒  
 Partial application of Harmonised standards ☐  
 Other standard testing method ☐

**Applicant's Name** ..... : **Fulton Science and Technology Lighting Co., Ltd**

**Address** ..... : 7F, Building 17, Area C, Liantang Industrial Town, Shangcun Community, Gongming Town, Guangming New District, Shenzhen, Guangdong Province, China.

**Test Specification:**

**Standard** ..... : EN 55015: 2013+A1: 2015  
 EN 61000-3-2: 2014  
 EN 61000-3-3: 2013  
 EN 61547: 2009

**Test Report Form No**..... : SLCSEMC-2.0

**TRF Originator** ..... : Shenzhen Southern LCS Compliance Testing Laboratory Ltd.

**Master TRF** ..... : Dated 2016-08

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**Test Item Description**..... : **LED TRI-PROOF LIGHT**

**Trade Mark** ..... : Fulton

**Test Model**..... : FLT-TPT-40L15

**Power Supply**..... : AC 220-240V, 50/60Hz, 40W

**Results** ..... : **PASS**

**Compiled by:**

*Kris Mai*

Kris Mai/ File administrators

**Supervised by:**

*Dm Gu*

Dm Gu/ Technique principal

**Approved by:**



Cherry Chen/ Manager

**EMC - TEST REPORT**

<b>Test Report No. :</b>	<b>LCS190910040BE</b>	<u>December 14, 2019</u> Date of issue
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EUT.....: LED TRI-PROOF LIGHT

Test Model.....: FLT-TPT-40L15

**Applicant .....** **Fulton Science and Technology Lighting Co., Ltd**Address .....: 7F, Building 17, Area C, Liantang Industrial Town, Shangcun  
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Community, Gongming Town, Guangming New District, Shenzhen,  
Guangdong Province, China.

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Fax .....: /

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Community, Gongming Town, Guangming New District, Shenzhen,  
Guangdong Province, China.

Telephone .....: /

Fax .....: /

**Test Result** according to the standards on page 6: **PASS**

The test report merely corresponds to the test sample.

It is not permitted to copy extracts of these test result without the written permission of the test laboratory.

**Revision History**

Revision	Issue Date	Revisions	Revised By
00	December 14, 2019	Initial Issue	Cherry Chen

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# 1. REPORT INFORMATION DESCRIPTION

## 1.1 Summary of Standards and Results

### 1.1.1 Description of Standards and Results

EMISSION (EN 55015: 2013+A1: 2015)			
Description of Test Item	Test Standard	Limits	Results
Conducted Disturbance at Mains Terminals	EN 55015: 2013+A1: 2015	-----	PASS
Conducted Disturbance at Load Terminals	EN 55015: 2013+A1: 2015	-----	N/A
Conducted Disturbance at Control Terminals	EN 55015: 2013+A1: 2015	-----	N/A
Radiated Disturbance (9kHz to 30MHz)	EN 55015: 2013+A1: 2015	-----	PASS
Radiated Disturbance (30MHz to 300MHz)	EN 55015: 2013+A1: 2015	-----	PASS
Harmonic Current Emissions*	EN 61000-3-2: 2014	Class C	PASS
Voltage Fluctuations & Flicker**	EN 61000-3-3: 2013	-----	N/A
IMMUNITY (EN 61547: 2009)			
Description of Test Item	Test Standard	Basic Standard	Results
Electrostatic Discharge Immunity Test (ESD)	EN 61547: 2009	EN 61000-4-2	PASS
Radiated, Radio-Frequency, Electromagnetic Field Immunity Test (RS)	EN 61547: 2009	EN 61000-4-3	PASS
Power Frequency Magnetic Field Immunity Test	EN 61547: 2009	EN 61000-4-8	N/A
Electrical Fast Transient/Burst Immunity Test (EFT)	EN 61547: 2009	EN 61000-4-4	PASS
Immunity to Conducted Disturbances, Induced by Radio-Frequency Fields (CS)	EN 61547: 2009	EN 61000-4-6	PASS
Surge Immunity Test ( a.c. Power Ports)	EN 61547: 2009	EN 61000-4-5	PASS
Voltage Dips, Short Interruptions and Voltage Variations Immunity Test	EN 61547: 2009	EN 61000-4-11	PASS
Note: “*” According to EN 61000-3-2:2014, for LED products $\leq 25$ watts, no limits are defined for the harmonics test, the EUT is deemed to comply with the standard without test.			
Note: N/A is an abbreviation for Not Applicable.			
Note: “**” Limits are not specified when LED luminaires with rating less than or equal to 200W(EN 61000-3-3:2013Annex A(A2))			

### 1.1.2 Performance Criteria

The performance of lighting equipment shall be assessed by monitoring:

- the luminous intensity of the luminaire or of the lamp(s).
- the functioning of the control in the case of equipment which includes a regulating control or concerns the regulating control itself.
- the functioning of the starting device, if any.

Performance criterion A: During the test, no change of the luminous intensity shall be observed and the regulating control, if any, shall operate during the test as intended.

Performance criterion B: During the test, the luminous intensity may change to any value. After the test, the luminous intensity shall be restored to its initial value within 1 min. Regulating controls need not function during the test, but after the test, the mode of the control shall be the same as before the test provided that during the test no mode changing commands were given.

Performance criterion C: During and after the test, any change of the luminous intensity is allowed and the lamp(s) may be extinguished. After the test, within 30 min, all functions shall return to normal, if necessary by temporary interruption of the mains supply and/or operating the regulating control.

Additional requirement for lighting equipment incorporating a starting device: After the test, the lighting equipment is switched off. After half an hour, it is switched on again. The lighting equipment shall start and operate as intended.

## 1.2 Product Information

### 1.2.1 Electrical parameter description

EUT : LED TRI-PROOF LIGHT

Trade Mark : Fulton

Test Model : FLT-TPT-40L15

Additional Models : FLT-TPT-10L6, FLT-TPT-15L6, FLT-TPT-20L6, FLT-TPT-20L12,  
FLT-TPT-30L12, FLT-TPT-40L12, FLT-TPT-30L15

Power Supply : AC220-240V, 50/60Hz, 40W

### 1.2.2 Test Modes

Lighting : EUT was test with power on, to get the status 'Lighting'

### 1.2.3 Test Auxiliary Equipment

Configuration	Model	Rating	Manufacturer

### 1.3 Description of Test Facility

EMC Lab. : TUV RH Registration Number. is UA 50418075 0001.  
UL Registration Number. is 100571-492.  
NVLAP Registration Code is 600112-0.

Test Facilities : Shenzhen Southern LCS Compliance Testing Laboratory Ltd.  
101-201, No.39 Building, Xialang Industrial Zone, Heshuikou  
Community, Matian Street, Guangming District, Shenzhen, China.

RF Field Strength : Shenzhen LCS Compliance Testing Laboratory Ltd.  
Susceptibility 1F., Xingyuan Industrial Park, Tongda Road, Bao'an Avenue., Bao'an  
District, Shenzhen, Guangdong, China.

## 2. STATEMENT OF THE MEASUREMENT UNCERTAINTY

The data and results referenced in this document are true and accurate. The reader is cautioned that there may be errors within the calibration limits of the equipment and facilities. The measurement uncertainty was calculated for all measurements listed in this test report acc. To CISPR 16 – 4 “Specification for radio disturbance and immunity measuring apparatus and methods – Part 4: Uncertainty in EMC Measurements” and is documented in the LCS quality system acc. To DIN EN ISO/IEC 17025. Furthermore, component and process variability of devices similar to that tested may result in additional deviation. The manufacturer has the sole responsibility of continued compliance of the device.

Test	Parameters	Expanded uncertainty ( $U_{lab}$ )	Expanded uncertainty ( $U_{cispr}$ )
Conducted Disturbance	Level accuracy (9kHz to 150kHz) (150kHz to 30MHz)	$\pm 1.40$ dB $\pm 2.80$ dB	$\pm 4.0$ dB $\pm 3.6$ dB
Electromagnetic Radiated Emission (3-loop)	Level accuracy (9kHz to 30MHz)	$\pm 3.46$ dB	N/A
Radiated Disturbance	Level accuracy (9kHz to 30MHz)	$\pm 3.12$ dB	N/A
Radiated Disturbance	Level accuracy (30MHz to 200MHz)	$\pm 4.66$ dB	$\pm 5.2$ dB
Radiated Disturbance	Level accuracy (200MHz to 1000MHz)	$\pm 4.64$ dB	$\pm 5.0$ dB
Harmonic Current	Voltage	$\pm 0.640\%$	N/A
Voltage Fluctuations & Flicker	Voltage	$\pm 0.530\%$	N/A

(1) Where relevant, the following measurement uncertainty levels have been estimated for tests performed on the apparatus.

(2) The reported expanded uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor of  $k=2$ , which for a normal distribution corresponds to a coverage probability of approximately 95%.

### 3. MEASURING DEVICES AND TEST EQUIPMENT

#### Conducted Disturbance

Item	Test Equipment	Manufacturer	Model No.	Serial No.	Due Date.
1	EMI Test Receiver	R&S	ESCI	101142	2020-06-20
2	10dB Attenuator	SCHWARZBECK	VTSD9561-F	9561-F159	2020-06-20
3	Artificial Mains	SCHWARZBECK	NSLK8127	8127716	2020-06-20
4	EMI Test Software	EZ	EZ EMC	N/A	2020-06-20
5	ISN CAT6	SCHWARZBECK	NTFM 8158	NTFM 8158#120	2020-06-20
6	Voltage Probe	SCHWARZBECK	KT 9420	9420401	2020-06-20

#### Radiated Disturbance(9kHz to 30MHz)

Item	Test Equipment	Manufacturer	Model No.	Serial No.	Due Date.
1	EMI Test Receiver	R&S	ESPI	101142	2020-06-20
2	Triple-loop Antenna	EVERFINE	LLA-2	9161	2020-06-20
3	EMI Test Software	EZ	EZ EMC	N/A	2020-06-20

#### Radiated Disturbance(30MHz to 300MHz)

Item	Test Equipment	Manufacturer	Model No.	Serial No.	Due Date.
1	3m Semi Anechoic Chamber	SIDT FRANKONIA	SAC-3M	03CH03-HY	2021-08-05
2	EMI Test Receiver	R&S	ESCI	101010	2020-06-20
3	Log per Antenna	SCHWARZBECK	VULB9163	5094	2020-06-23
4	EMI Test Software	AUDIX	E3	N/A	2020-06-20
5	Positioning Controller	MF	BK8807-4A-2T	2016-0808-008	2020-06-20

#### Harmonic Current&Voltage Fluctuation and Flicker

Item	Test Equipment	Manufacturer	Model No.	Serial No.	Due Date.
1	Power Analyzer Test System	Laplace	AC2000A	/	2020-06-20

#### Electrostatic Discharge Immunity Test (ESD)

Item	Test Equipment	Manufacturer	Model No.	Serial No.	Due Date.
1	ESD Simulator	KIKUSUI	KES4021	KC001311	2020-06-24

#### Electrical Fast Transient/Burst Immunity Test (EFT)

Item	Test Equipment	Manufacturer	Model No.	Serial No.	Due Date.
1	Electrical fast transient(EFT)generator	HTEC	HEFT51	162201	2020-06-20
2	Coupling Clamp	HTEC	H3C	163701	2020-06-20

**Surge Immunity Test**

Item	Test Equipment	Manufacturer	Model No.	Serial No.	Due Date.
1	Surge test system	3CTEST	SG5006G	EC5581070	2020-06-20
2	Coupling/decoupling network	3CTEST	SGN-5010G	EC5591033	2020-06-20

**Immunity to Conducted Disturbances, Induced by Radio-Frequency Fields (CS)**

Item	Test Equipment	Manufacturer	Model No.	Serial No.	Due Date.
1	Conducted Susceptibility Generator	HTEC	CDG6000	126A140012016	2020-06-20
2	CDN	HTEC	CDN-M2+M3	A22/0382/2016	2020-06-25
3	Attenuator	HTEC	ATT6	HA1601	2020-06-20
4	Electromagnetic Injection Clamp	LUTHI	EM101	35535	2020-06-20

**Voltage Dips, Short Interruptions and Voltage Variations Immunity Test**

Item	Test Equipment	Manufacturer	Model No.	Serial No.	Due Date.
1	Voltage dips and up generator	HTEC	HPFS161P	162202	2020-06-20

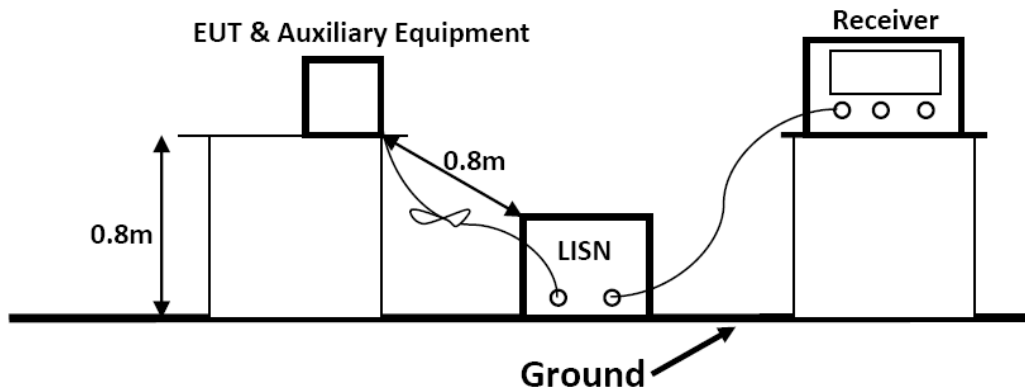
**Radiated, Radio-Frequency, Electromagnetic Field Immunity Test (RS)-LCS**

Item	Test Equipment	Manufacturer	Model No.	Serial No.	Due Date.
1	RS Test Software	Tonscend	/	/	N/A
2	ESG Vector Signal Generator	Agilent	E4438C	MY42081396	2020-11-14
3	3m Semi Anechoic Chamber	SIDT FRANKONIA	SAC-3M	03CH03-HY	2020-06-11
4	RF POWER AMPLIFIER	OPHIR	5225R	1052	NCR
5	RF POWER AMPLIFIER	OPHIR	5273F	1019	NCR
6	Stacked Broadband Log Periodic Antenna	SCHWARZBECK	STLP 9128	9128ES-145	NCR
7	Stacked Mikrowellen Log.-Per Antenna	SCHWARZBECK	STLP 9149	9149-484	NCR
8	RS Test Software	Tonscend	/	/	2020-03-24

## 4. TEST DETAILS

### 4.1 Conducted Disturbance at Mains Terminals

#### 4.1.1 Block Diagram of Test Setup



#### 4.1.2 Test Standard

EN 55015: 2013+A1: 2015

#### 4.1.3 Limits

Disturbance voltage limits at the Mains Terminals		
Frequency range	Limits (dB $\mu$ V)	
	Quasi-peak	Average
9kHz to 50kHz	110	--
50kHz to 150kHz	90 ~ 80*	--
150kHz to 0.5MHz	66 ~ 56*	56 ~ 46*
0.5MHz to 5.0MHz	56	46
5.0MHz to 30MHz	60	50

1. At the transition frequency the lower limit applies.
2. \* The limit decreases linearly with the logarithm of the frequency in the ranges 50 kHz to 150 kHz and 150 kHz to 0,5 MHz.

#### 4.1.4 EUT Configuration on Test

The configuration of the EUT is same as Section 3

#### 4.1.5 Test Procedure Description

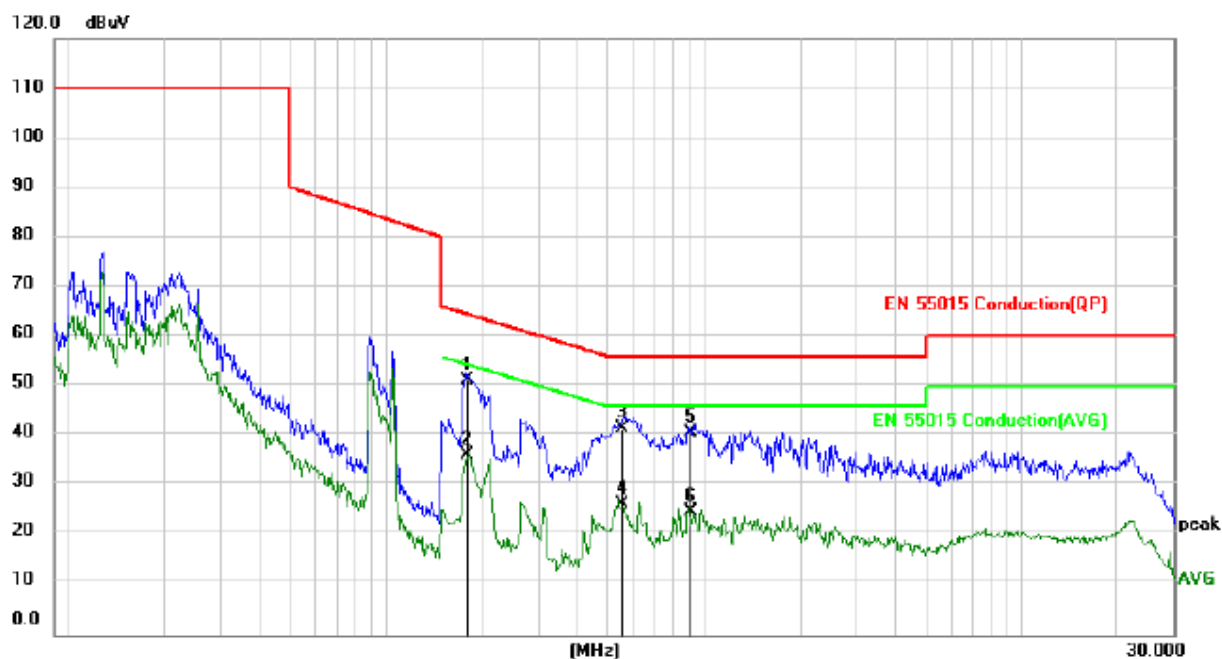
The EUT is put on the table which is 0.8 meter high above the ground and connected to the AC mains through a Line Impedance Stabilization Network (L.I.S.N.). This provided a 50ohm coupling impedance for the tested equipments. Both sides of AC line are checked to find out the maximum conducted emission according to the EN 55015 regulations during conducted emission measurement. And the voltage probe had been used for the load terminals measurement according to the EN 55015 standard.

The bandwidth of the test receiver is set at 200Hz in 9k~150kHz range and 9kHz in 150k~30MHz range.

#### 4.1.6 Test Results: PASS

Environmental Conditions:	23.7°C, 51% RH
Test Voltage:	AC 230V,50Hz
Test Model:	FLT-TPT-40L15
Test Mode:	Lighting
Test Engineer:	DEAN YA
Pol:	Line

Detailed results are shown below



No.	Mk.	Freq. MHz	Reading Level dBuV	Correct Factor dB	Measure- ment dBuV	Limit dBuV	Over dB	Detector	Comment
1	*	0.1783	40.87	10.23	51.10	64.56	-13.46	QP	
2		0.1783	26.00	10.23	36.23	54.56	-18.33	AVG	
3		0.5518	31.44	10.20	41.64	56.00	-14.36	QP	
4		0.5518	16.20	10.20	26.40	46.00	-19.60	AVG	
5		0.9171	30.48	10.20	40.68	56.00	-15.32	QP	
6		0.9171	14.56	10.20	24.76	46.00	-21.24	AVG	

Environmental Conditions:	23.7°C, 51% RH
Test Voltage:	AC 230V,50Hz
Test Model:	FLT-TPT-40L15
Test Mode:	Lighting
Test Engineer:	DEAN YA
Pol:	Neutral

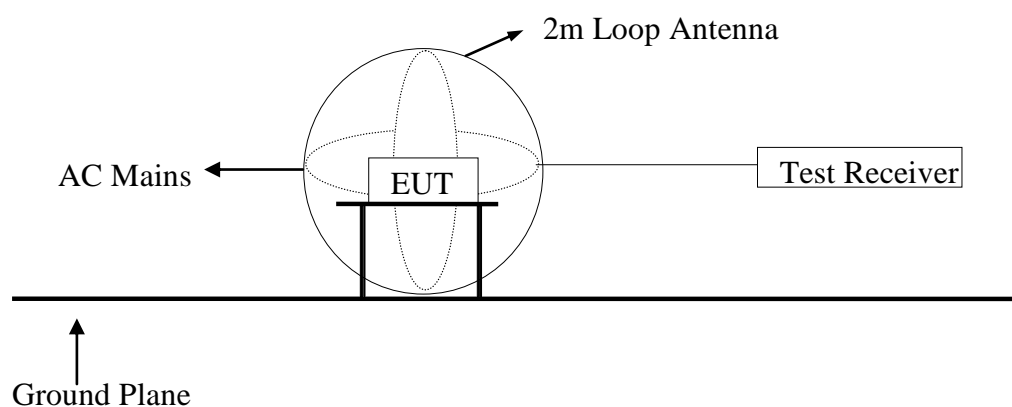
Detailed results are shown below



No.	Mk.	Freq. MHz	Reading Level dBuV	Correct Factor dB	Measure- ment dBuV	Limit dBuV	Over dB	Detector	Comment
1	*	0.1766	43.48	10.23	53.71	64.64	-10.93	QP	
2		0.1766	26.68	10.23	36.91	54.64	-17.73	AVG	
3		0.5991	27.33	10.20	37.53	56.00	-18.47	QP	
4		0.5991	10.28	10.20	20.48	46.00	-25.52	AVG	
5		2.1152	29.25	10.20	39.45	56.00	-16.55	QP	
6		2.1152	14.93	10.20	25.13	46.00	-20.87	AVG	

## 4.2 Radiated Disturbance (9kHz to 30MHz)

### 4.2.1 Block Diagram of Test Setup



### 4.2.2 Test Standard

EN 55015: 2013+A1: 2015

### 4.2.3 Limits

Radiated Disturbance limits (9KHz-30MHz)	
Frequency range	Limits for loop diameter (dBμA)
	2m
9kHz to 70kHz	88
70kHz to 150kHz	88 to 58*
150kHz to 3.0MHz	58 to 22*
3.0MHz to 30MHz	22

1. At the transition frequency the lower limit applies.
- 2.\* Decreasing linearly with logarithm of the frequency.

### 4.2.4 EUT Configuration on Test

The configuration of the EUT is same as Section 3

### 4.2.5 Test Procedure

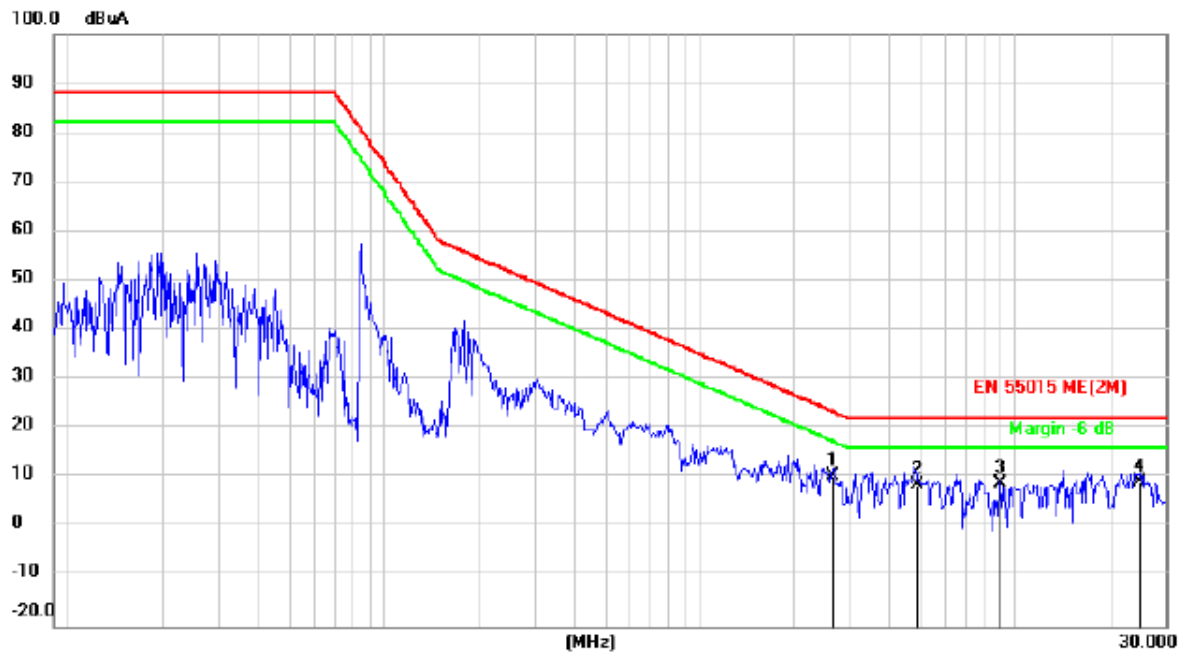
The EUT is placed on a wood table in the center of a loop antenna. The induced current in the loop antenna is measured by means of a current probe and the test receiver. Three field components are checked by means of a coaxial switch.

The frequency range from 9kHz to 30MHz is investigated. The receiver is measured with the quasi-peak detector. For frequency band 9kHz to 150kHz, the bandwidth of the field strength meter is set at 200Hz. For frequency band 150kHz to 30MHz, the bandwidth is set at 9kHz.

#### 4.2.6 Test Results: PASS

Environmental Conditions:	23.7°C, 51% RH
Test Voltage:	AC 230V, 50Hz
Test Model:	FLT-TPT-40L15
Test Mode:	Lighting
Test Engineer:	DEAN YA
Pol:	X

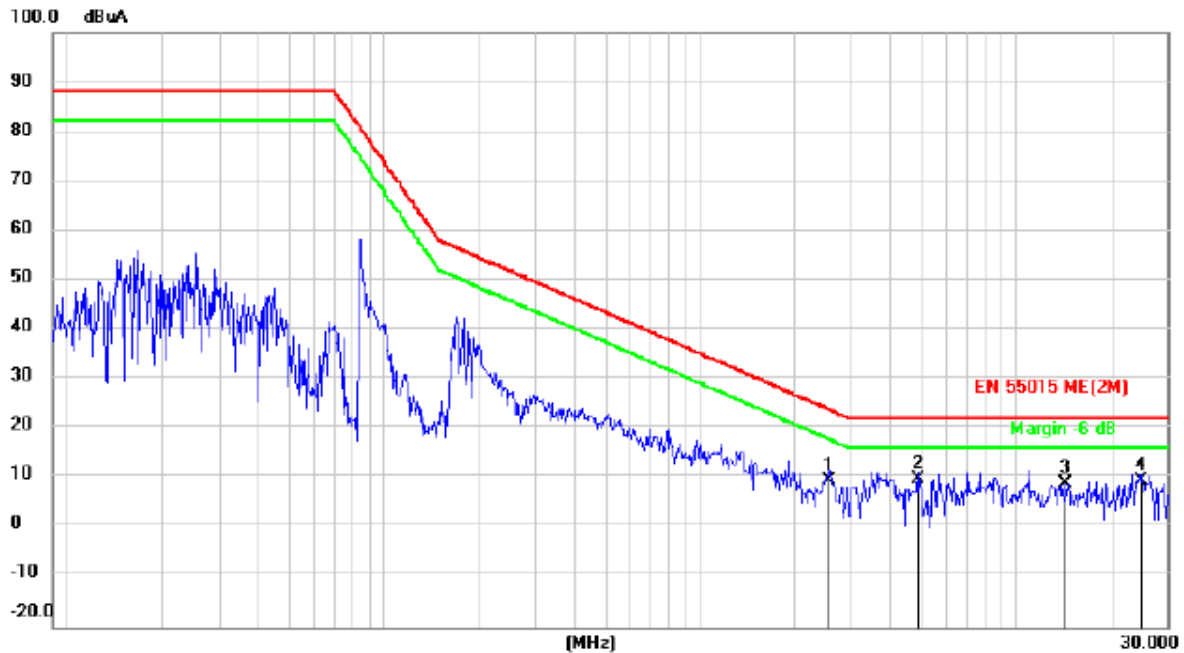
Detailed results are shown below



No.	Mk.	Freq. MHz	Reading Level dBuA	Correct Factor dB	Measure- ment dBuA	Limit dBuA	Over dB	Detector	Comment
1		2.6318	10.45	0.00	10.45	23.57	-13.12	QP	
2		4.8752	8.57	0.00	8.57	22.00	-13.43	QP	
3		8.9580	12.42	-3.44	8.98	22.00	-13.02	QP	
4	*	24.8933	29.21	-20.00	9.21	22.00	-12.79	QP	

Environmental Conditions:	23.7°C, 51% RH
Test Voltage:	AC 230V,50Hz
Test Model:	FLT-TPT-40L15
Test Mode:	Lighting
Test Engineer:	DEAN YA
Pol:	Y

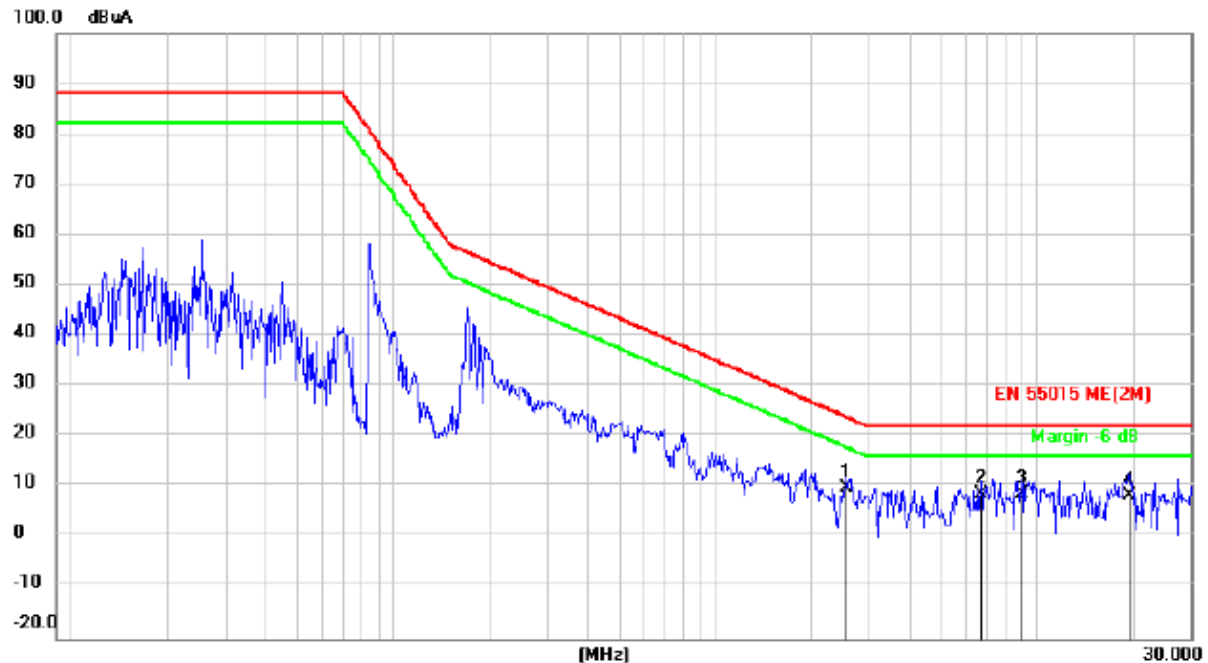
Detailed results are shown below



No.	Mk.	Freq. MHz	Reading Level dBuA	Correct Factor dB	Measure- ment dBuA	Limit dBuA	Over dB	Detector	Comment
1		2.5478	9.12	0.38	9.50	23.96	-14.46	QP	
2	*	4.8752	10.25	-0.33	9.92	22.00	-12.08	QP	
3		14.3397	20.91	-12.01	8.90	22.00	-13.10	QP	
4		24.8931	29.63	-20.13	9.50	22.00	-12.50	QP	

Environmental Conditions:	23.7°C, 51% RH
Test Voltage:	AC 230V,50Hz
Test Model:	FLT-TPT-40L15
Test Mode:	Lighting
Test Engineer:	DEAN YA
Pol:	Z

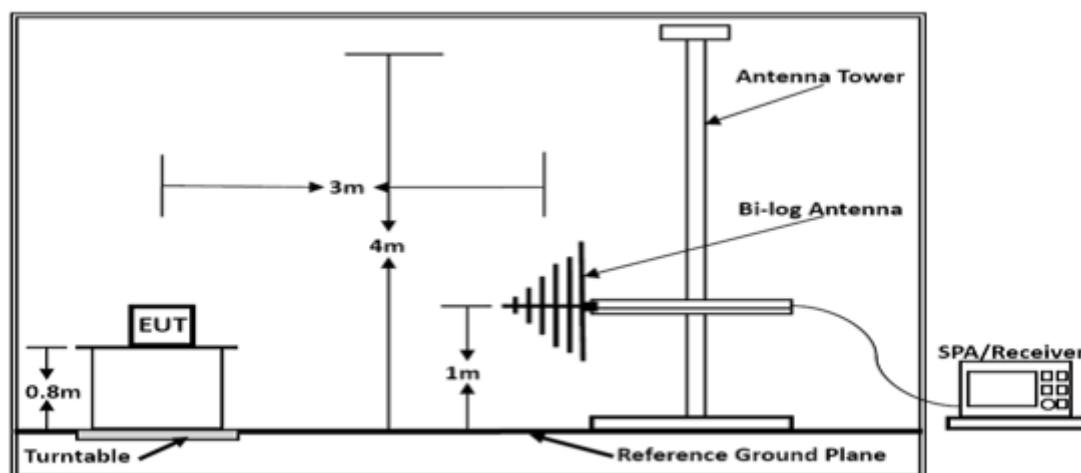
Detailed results are shown below



No.	Mk.	Freq. MHz	Reading Level dBuA	Correct Factor dB	Measure- ment dBuA	Limit dBuA	Over dB	Detector	Comment
1		2.5684	9.96	0.02	9.98	23.87	-13.89	QP	
2		6.6894	9.56	-0.96	8.60	22.00	-13.40	QP	
3	*	8.9580	12.39	-3.59	8.80	22.00	-13.20	QP	
4		19.3591	23.10	-14.84	8.26	22.00	-13.74	QP	

## 4.3 Radiated Disturbance (30MHz to 300MHz)

### 4.3.1 Block Diagram of Test Setup



### 4.3.2 Test Standard

EN 55015: 2013+A1: 2015

### 4.3.3 Limits

Radiated Disturbance Limits at a measuring distance of 3m (30MHz-300MHz)	
Frequency range (MHz)	Quasi-Peak Limits(dB $\mu$ V/m)
30 ~ 230	40
230 ~ 300	47

- 1, At the transition frequency, the lower limit applies.
- 2, Distance refers to the distance in meters between the measuring instrument antenna geometric center and the closed point of any part of the EUT.

### 4.3.4 EUT Configuration on Test

The configuration of the EUT is same as Section 3.

The EN 55015 regulations test method must be used to find the maximum emission during radiated emission measurement.

#### **4.3.5 Test Procedure**

The EUT is placed on a turntable, which is 0.8 meter high above the ground. The turntable can rotate 360 degrees to determine the position of the maximum emission level. The EUT is set 3 meters away from the receiving antenna, which is mounted on an antenna tower. The antenna can be moved up and down from 1 to 4 meters to find out the maximum emission level. By-log antenna (calibrated by Dipole Antenna) is used as a receiving antenna. Both horizontal and vertical polarization of the antenna is set on test.

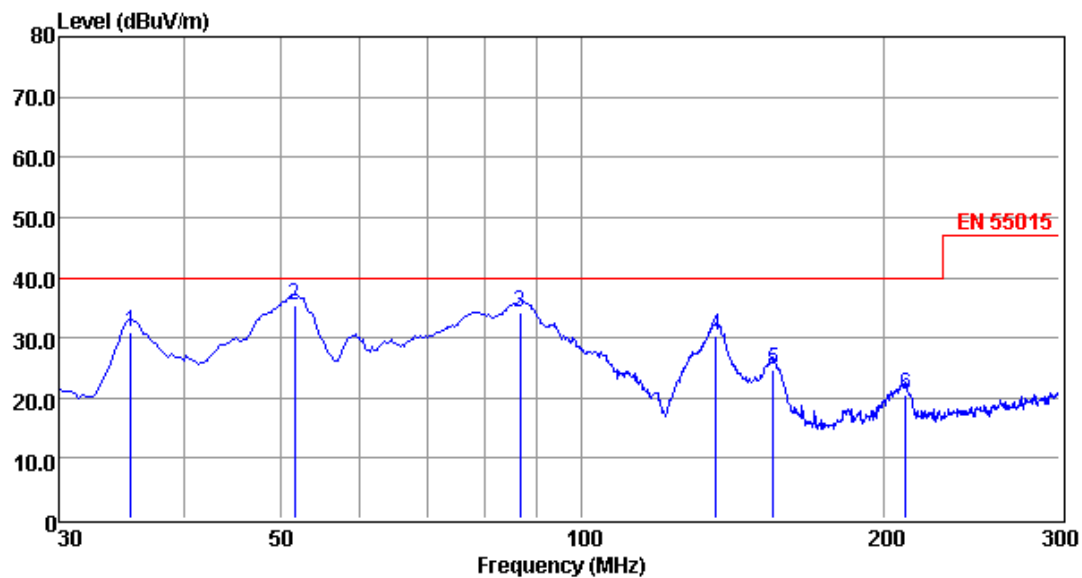
The bandwidth of the Receiver is set at 120kHz; The frequency range from 30MHz to 300MHz is investigated.

#### **4.3.6 Test Results: PASS**

The test result please refer to the next page.

Environmental Conditions:	24°C, 56% RH
Test Voltage:	AC 230V,50Hz
Test Model:	FLT-TPT-40L15
Test Mode:	Lighting
Test Engineer:	DEAN YA
Pol:	Vertical

Detailed results are shown below



	Freq	Reading	CabLos	Antfac	Measured	Limit	Over	Remark
	MHz	dBuV	dB	dB/m	dBuV/m	dBuV/m	dB	
1	35.40	18.06	0.41	12.40	30.87	40.00	-9.13	QP
2	51.60	21.54	0.54	13.18	35.26	40.00	-4.74	QP
3	86.70	22.88	0.47	10.85	34.20	40.00	-5.80	QP
4	136.11	21.12	0.70	8.48	30.30	40.00	-9.70	QP
5	155.28	15.59	0.76	8.48	24.83	40.00	-15.17	QP
6	210.90	8.77	0.93	10.91	20.61	40.00	-19.39	QP

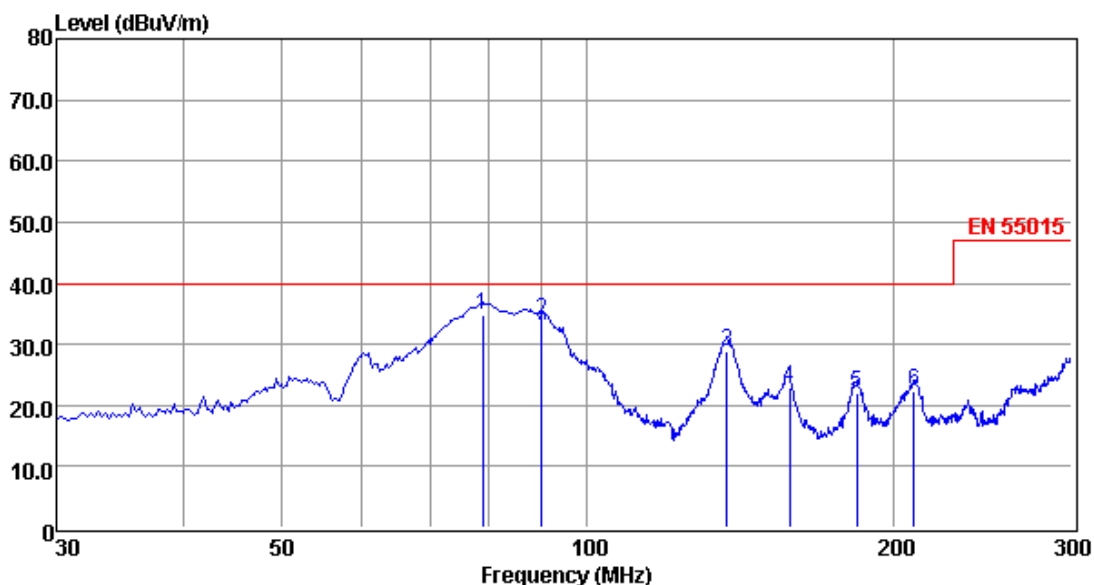
Note: 1. All readings are Quasi-peak values.

2. Measured= Reading + Antenna Factor + Cable Loss

3. The emission that are 20dB below the official limit are not reported

Environmental Conditions:	24°C, 56% RH
Test Voltage:	AC 230V,50Hz
Test Model:	FLT-TPT-40L15
Test Mode:	Lighting
Test Engineer:	DEAN YA
Pol:	Horizontal

Detailed results are shown below



	Freq	Reading	CabLos	Antfac	Measured	Limit	Over	Remark
	MHz	dBuV	dB	dB/m	dBuV/m	dBuV/m	dB	
1	78.87	25.90	0.47	8.37	34.74	40.00	-5.26	QP
2	90.21	21.14	0.68	11.94	33.76	40.00	-6.24	QP
3	137.19	19.72	0.70	8.40	28.82	40.00	-11.18	QP
4	158.25	13.42	0.83	8.60	22.85	40.00	-17.15	QP
5	184.44	11.23	0.70	10.07	22.00	40.00	-18.00	QP
6	209.82	10.39	0.93	10.88	22.20	40.00	-17.80	QP

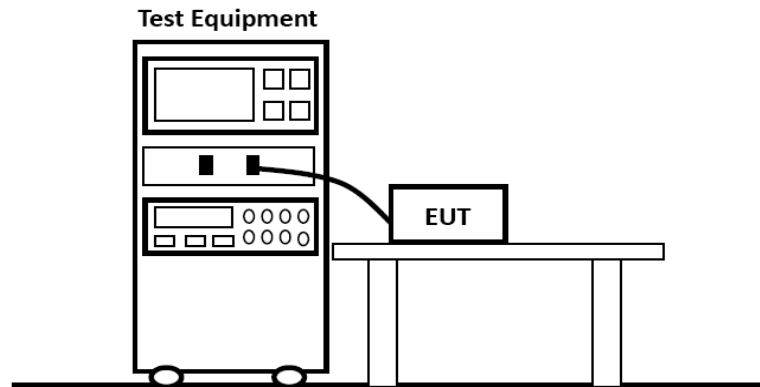
Note: 1. All readings are Quasi-peak values.

2. Measured= Reading + Antenna Factor + Cable Loss

3. The emission that are 20dB below the official limit are not reported

## 4.4 Harmonic Current Emissions

### 4.4.1 Block Diagram of Test Setup



### 4.4.2 Test Standard

EN 61000-3-2: 2014

### 4.4.3 Limits

Limits for Class C Equipment	
Harmonic order	Maximum permissible harmonic current expressed as a percentage of the input current at the fundamental frequency
n	%
2	2
3	$30 \cdot \lambda^*$
5	10
7	7
$11 \leq n \leq 39$	5
(odd harmonics only)	
* $\lambda$ is the circuit power factor	

### 4.4.4 EUT Configuration on Test

The configuration of the EUT is same as Section 3

### 4.4.5 Test Results: PASS

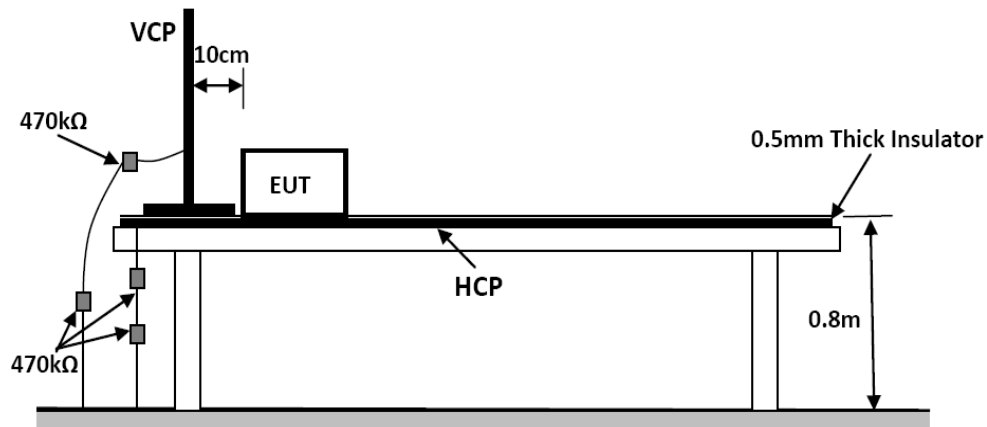
The test result please refer to the next page.

Test Model:	FLT-TPT-40L15				
Test Voltage:	AC 230V,50Hz				
Test Mode:	Lighting				
Test Engineer:	DEAN YA				
Detailed results are shown below					
Nominal Supply Voltage : 230 Nominal Supply Frequency : 50 Nominal Crest Phase : 90.0 Nominal Crest Factor : 1.414					
	Measured Low	Measured High	Deviation	Allowed Deviation	Result
Supply Voltage	: 229.15	229.21	-0.85	4.60	PASS
Supply Frequency	: 49.99	50.00	-0.01	0.25	PASS
Crest Phase	: 89.1	89.2	-0.9	3.0	PASS
Crest Factor	: 1.414	1.414	0.000	-0.014/+0.006	PASS
Fundamental Voltage	: 229.17	-	-	-	-
Harmonic	Harmonic Voltage	Harmonic Ratio	Limit	Result	
2	0.09	0.058	0.20	PASS	
3	0.23	0.110	0.90	PASS	
4	0.02	0.023	0.20	PASS	
5	0.11	0.060	0.40	PASS	
6	0.02	0.015	0.20	PASS	
7	0.04	0.025	0.30	PASS	
8	0.01	0.007	0.20	PASS	
9	0.02	0.010	0.20	PASS	
10	0.02	0.011	0.10	PASS	
11	0.02	0.008	0.10	PASS	
12	0.00	0.003	0.10	PASS	
13	0.01	0.010	0.10	PASS	
14	0.00	0.003	0.10	PASS	
15	0.00	0.003	0.10	PASS	
16	0.01	0.003	0.10	PASS	
17	0.00	0.003	0.10	PASS	
18	0.00	0.000	0.10	PASS	
19	0.01	0.005	0.10	PASS	
20	0.00	0.000	0.10	PASS	
21	0.00	0.005	0.10	PASS	
22	0.00	0.000	0.10	PASS	
23	0.00	0.001	0.10	PASS	
24	0.00	0.000	0.10	PASS	
25	0.00	0.000	0.10	PASS	
26	0.00	0.000	0.10	PASS	
27	0.00	0.003	0.10	PASS	
28	0.00	0.000	0.10	PASS	
29	0.00	0.000	0.10	PASS	
30	0.00	0.000	0.10	PASS	
31	0.00	0.003	0.10	PASS	
32	0.00	0.000	0.10	PASS	
33	0.00	0.004	0.10	PASS	
34	0.00	0.000	0.10	PASS	
35	0.00	0.003	0.10	PASS	
36	0.00	0.000	0.10	PASS	
37	0.00	0.003	0.10	PASS	
38	0.00	0.000	0.10	PASS	
39	0.01	0.005	0.10	PASS	
40	0.00	0.000	0.10	PASS	

Test Model:	FLT-TPT-40L15					
Test Voltage:	AC 230V,50Hz					
Test Mode:	Lighting					
Test Engineer:	DEAN YA					
Detailed results are shown below						
Load Power : 38.530 W 42.32 VA Power Factor 0.910						
Load Current : 184.6 mArms 311.9 mApk Crest Factor 1.689						
Measurement Standard : EN61000-4-7:2002+A1:2009						
Limits Applied : EN61000-3-2:2014 Class C Limits >25W Professional, for 0.180A at 0.910 PF.						
Harmonic Number	Limit Current mA	Average (filtered) mA	% Limit	max. Value (Filtered) mA	% Limit	Assessment
Fundamental :		180.5				
2 :	3.6	0.1	2.8	0.16	4.4	Pass
3 :	49.2	41.2	83.7	41.89	85.1	Pass
4 :	-	0.1	-	0.15	-	-
5 :	18.1	10.5	58.0	10.89	60.2	Pass
6 :	-	0.1	-	0.12	-	-
7 :	12.7	1.1	8.7	1.22	9.6	Pass
8 :	-	0.1	-	0.12	-	-
9 :	9.1	2.6	28.6	2.71	29.8	Pass
10 :	-	0.1	-	0.13	-	-
11 :	5.4	1.7	31.5	1.83	33.9	Pass
12 :	-	0.1	-	0.13	-	-
13 :	5.4	2.8	51.9	2.80	51.9	Pass
14 :	-	0.1	-	0.12	-	-
15 :	5.4	1.6	29.6	1.73	32.0	Pass
16 :	-	0.1	-	0.13	-	-
17 :	5.4	1.4	25.9	1.53	28.3	Pass
18 :	-	0.1	-	0.12	-	-
19 :	5.4	2.1	38.9	2.16	40.0	Pass
20 :	-	0.1	-	0.12	-	-
21 :	5.4	1.4	25.9	1.48	27.4	Pass
22 :	-	0.1	-	0.11	-	-
23 :	5.4	0.7	13.0	0.77	14.3	Pass
24 :	-	0.1	-	0.11	-	-
25 :	5.4	0.3	5.6	0.37	6.9	Pass
26 :	-	0.1	-	0.10	-	-
27 :	5.4	0.6	11.1	0.65	12.0	Pass
28 :	-	0.1	-	0.10	-	-
29 :	5.4	0.1	1.9	0.22	4.1	Pass
30 :	-	0.1	-	0.10	-	-
31 :	5.4	0.7	13.0	0.67	12.4	Pass
32 :	-	0.1	-	0.11	-	-
33 :	5.4	1.2	22.2	1.22	22.6	Pass
34 :	-	0.1	-	0.11	-	-
35 :	5.4	0.9	16.7	1.00	18.5	Pass
36 :	-	0.1	-	0.11	-	-
37 :	5.4	0.4	7.4	0.48	8.9	Pass
38 :	-	0.1	-	0.11	-	-
39 :	5.4	0.7	13.0	0.74	13.7	Pass
40 :	-	0.1	-	0.12	-	-
21 - 39 :	17.2	2.5	14.5	2.55	14.8	-

## 4.5 Electrostatic Discharge Immunity Test

### 4.5.1 Block Diagram of Test Setup



### 4.5.2 Test Standard

EN 61547:2009

### 4.5.3 Limits

Electrostatic discharges — Test levels				
Discharge Type	Discharge Level (KV)		Number of discharges (Each point)	Performance Criteria
	+	-		
Air Discharge-Direct	2, 4, 8	2, 4, 8	20	B
Contact Discharge-Direct	2, 4	2, 4	20	B
Contact Discharge Indirect	2, 4	2, 4	20	B

### 4.5.4 EUT Configuration on Test

The configuration of the EUT is same as Section 3

#### 4.5.5 Test Procedure

a) Air Discharge

This test is done on a non-conductive surfaces. The round discharge tip of the discharge electrode shall be approached as fast as possible to touch the EUT. After each discharge, the discharge electrode shall be removed from the EUT. The generator is then re-triggered for a new single discharge and repeated 10 times for each pre-selected test point. This procedure shall be repeated until all the air discharge completed.

b) Contact Discharge

All the procedure shall be same as Section a. except that the tip of the discharge electrode shall touch the EUT before the discharge switch is operated.

c) Indirect Discharge For Horizontal Coupling Plane

At least 20 single discharges shall be applied to the horizontal coupling plane, at points on each side of the EUT. The discharge electrode positions vertically at a distance of 0.1m from the EUT and with the discharge electrode touching the coupling plane.

d) Indirect Discharge For Vertical Coupling Plane

At least 20 single discharge shall be applied to the center of one vertical edge of the coupling plane. The coupling plane, of dimensions 0.5m \* 0.5m, is placed parallel to, and positioned at a distance of 0.1m from the EUT. Discharges shall be applied to the coupling plane, with this plane in sufficient different positions that the four faces of the EUT are completely illuminated.

#### 4.5.6 Test Results: PASS

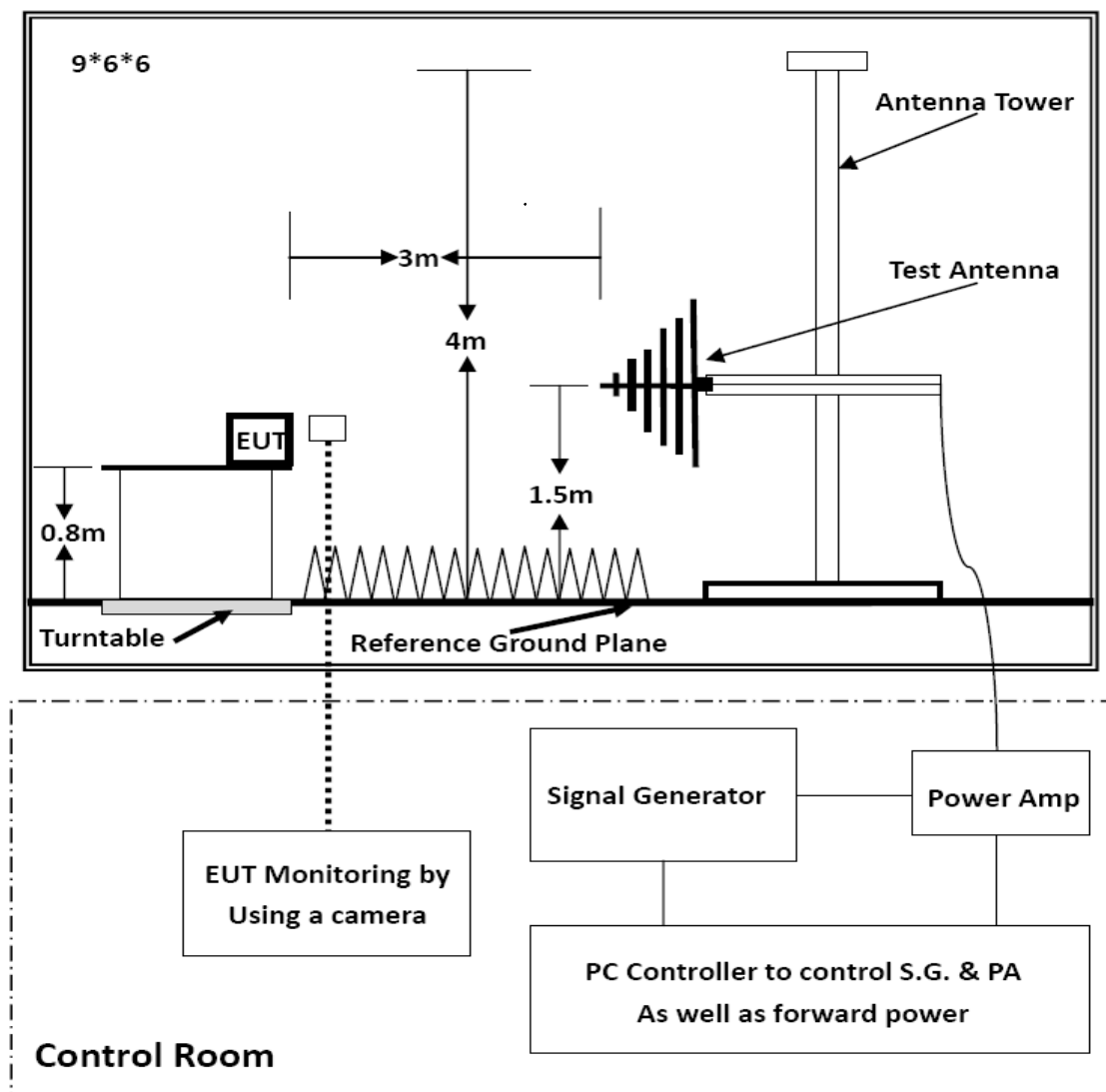
Please refer to the following page.

## Electrostatic Discharge Immunity Test Results

Standard	☑ EN 61547: 2009		☑ EN 61000-4-2 : 2006					
Applicant	Fulton Science and Technology Lighting Co., Ltd							
EUT	LED TRI-PROOF LIGHT	Temperature	23.3℃					
M/N	FLT-TPT-40L15	Humidity	52%					
Test Mode	Lighting	Pressure	1008mbar					
Input Voltage	AC 230V,50Hz	Test Results	Pass					
Test Engineer	DEAN YA							
Discharge mode	Test points	Results						Performance Criteria
		2kv		4kv		8kv		
		+	-	+	-	+	-	
Direct-Contact Discharge	Front	P	P	P	P	/	/	B
	Back	P	P	P	P	/	/	B
	Left	P	P	P	P	/	/	B
	Right	P	P	P	P	/	/	B
	Top	P	P	P	P	/	/	B
	Bottom	P	P	P	P	/	/	B
Direct-Air Discharge	Front	P	P	P	P	P	P	B
	Back	P	P	P	P	P	P	B
	Left	P	P	P	P	P	P	B
	Right	P	P	P	P	P	P	B
	Top	P	P	P	P	P	P	B
	Bottom	P	P	P	P	P	P	B
Indirect-Contact Discharge (VCP)	Front	P	P	P	P	/	/	B
	Back	P	P	P	P	/	/	B
	Left	P	P	P	P	/	/	B
	Right	P	P	P	P	/	/	B
Indirect-Contact Discharge (HCP)	Front	P	P	P	P	/	/	B
	Back	P	P	P	P	/	/	B
	Left	P	P	P	P	/	/	B
	Right	P	P	P	P	/	/	B
Note: “P” = Pass.								

## 4.6 Radiated, Radio-Frequency, Electromagnetic Field Immunity Test

### 4.6.1 Block Diagram of Test Setup



### 4.6.2 Test Standard

EN 61547:2009

### 4.6.3 Limits

Radio-frequency electromagnetic fields – Test levels		
Characteristics	Test levels	Performance Criteria
Frequency range	80 MHz to 1 000 MHz	A
Test level	3 V/m (unmodulated)	A
Modulation	1 kHz, 80 % AM, sine wave	A

### 4.6.4 EUT Configuration on Test

The configuration of the EUT is same as Section 3.

#### 4.6.5 Test Procedure

The EUT and its simulators are placed on a turn table which is 0.8 meter above ground. EUT is set 3 meter away from the transmitting antenna which is mounted on an antenna tower. Both horizontal and vertical polarization of the antenna are set on test. Each of the four sides of EUT must be faced this transmitting antenna and measured individually. In order to judge the EUT performance, a CCD camera is used to monitor EUT screen. All the scanning conditions are as follows:

Condition of Test	Remarks
-----	-----
Fielded Strength	3 V/m
Radiated Signal	Unmodulated
Scanning Frequency	80 - 1000 MHz
Dwell time of radiated	0.0015 decade/s
Waiting Time	3 Sec.
1. -	

#### 4.6.6 Test Results: PASS

Please refer to the following page.

## Radiated, Radio-Frequency, Electromagnetic Field Immunity Test Results

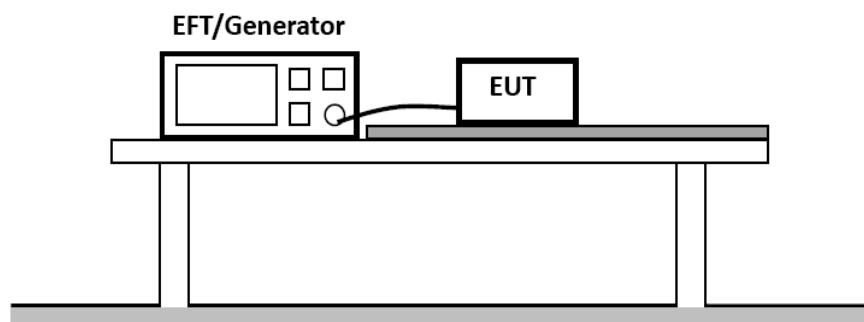
Standard	<input checked="" type="checkbox"/> EN 61547: 2009 <input checked="" type="checkbox"/> EN 61000-4-3: 2006+A2: 2010		
Applicant	Fulton Science and Technology Lighting Co., Ltd		
EUT	LED TRI-PROOF LIGHT	Temperature	23.5℃
M/N	FLT-TPT-40L15	Humidity	53%
Test Mode	Lighting	Pressure	1008mbar
Input Voltage	AC 230V,50Hz	Test Engineer	Davey Xu
Modulation	80% AM 1KHz	Test Results	Pass
Steps	1%		

Side of EUT	Antenna polarization	Frequency Range (MHz)	Test Level (V/m)	Performance Criteria
Front	Vertical, Horizontal	80 to 1000	3	A
Right	Vertical, Horizontal	80 to 1000	3	A
Rear	Vertical, Horizontal	80 to 1000	3	A
Left	Vertical, Horizontal	80 to 1000	3	A

Note:

## 4.7 Electrical Fast Transient/Burst Immunity Test

### 4.7.1 Block Diagram of Test Setup



### 4.7.2 Test Standard

EN 61547:2009

### 4.7.3 Limits

Fast transients - Test levels at input and output a.c. power ports						
Test Levels	Repetition Frequency	Burst Duration	Burst Period	Test Duration	Coupling Method	Performance Criteria
±1 kV	5 kHz	15ms	300ms	2 min per polarity	Direct	B

Fast transients - Test levels at input and output d.c. power ports						
Test Levels	Repetition Frequency	Burst Duration	Burst Period	Test Duration	Coupling Method	Performance Criteria
±0.5kV	5 kHz	15ms	300ms	2 min per polarity	Direct	B

Note: Not applicable to equipment not connected to the mains while in use.

Fast transients - Test levels at ports for signal and control lines						
Test Levels	Repetition Frequency	Burst Duration	Burst Period	Test Duration	Coupling Method	Performance Criteria
±0.5kV	5 kHz	15ms	300ms	2 min per polarity	Direct	B

Note 1: Only applicable to ports interfacing with cables whose total length, according to the manufacturer's specification, may exceed 3 m.

Note 2: Change of state commands are not applied during the test.

#### **4.7.4 EUT Configuration on Test**

The configuration of the EUT is same as Section 3

#### **4.7.5 Test Procedure**

The EUT is put on the table which is 0.8 meter high above the ground. This reference ground plane shall project beyond the EUT by at least 0.1m on all sides and the minimum distance between EUT and all other conductive structure, except the ground plane beneath the EUT, shall be more than 0.5m.

The EUT is connected to the power mains by using a coupling device which couples the EFT interference signal to AC power lines. Both polarities of the test voltage should be applied during compliance test, Fast transients are carried out with a minimum duration of 2 min with a positive polarity and a minimum of 2 min with a negative polarity

#### **4.7.6 Test Results: PASS**

Please refer to the following page.

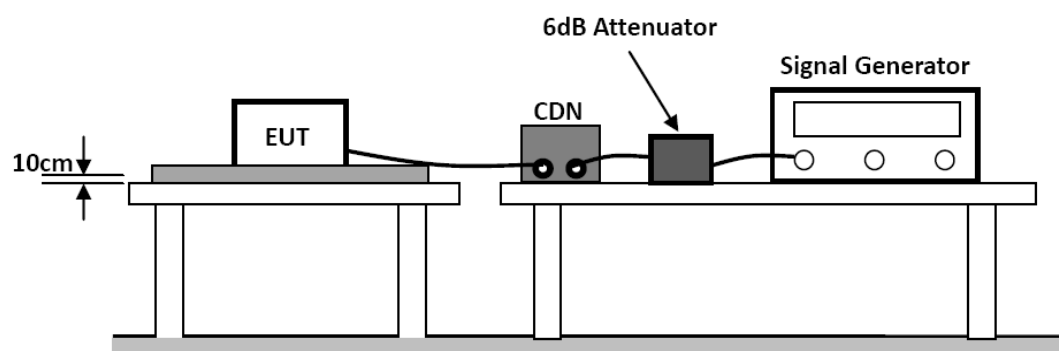
## Electrical Fast Transient/Burst Immunity Test Results

Standard	☑ EN 61547: 2009                      ☑ EN 61000-4-4: 2012				
Applicant	Fulton Science and Technology Lighting Co., Ltd				
EUT	LED TRI-PROOF LIGHT	Temperature	23.5℃		
M/N	FLT-TPT-40L15	Humidity	53%		
Test Mode	Lighting	Pressure	1008mbar		
Input Voltage	AC 230V,50Hz	Test Results	Pass		
Test Engineer	DEAN YA				
Line Under Test	Test Level	Repetition Frequency	Test Duration		Performance Criteria
			+	-	
AC Power ports	±1.0kV	5kHz	2min	2min	B
Signal/Control lines					
DC Input /Output Power ports					

Note:

## 4.8 Immunity to Conducted Disturbances, Induced by Radio-Frequency Fields

### 4.8.1 Block Diagram of Test Setup



### 4.8.2 Test Standard

EN 61547:2009

### 4.8.3 Limits

Radio-frequency common mode – Test levels at input and output a.c. power ports					
Frequency range (MHz)	Test Level (V/m)	Modulation Signal	Coupling Method	Steps	Performance Criteria
0.15 to 80	3	1kHz, 80%, AM, Sine wave	CDN	1%	A
Note: Only applicable to ports interfacing with cables whose total length, according to the manufacturer's specification, may exceed 3 m.					

Radio-frequency common mode – Test levels at input and output d.c. power ports					
Frequency range (MHz)	Test Level (V/m)	Modulation Signal	Coupling Method	Steps	Performance Criteria
0.15 to 80	3	1kHz, 80%, AM, Sine wave	CDN	1%	A
Note: Only applicable to equipment that is connected to the mains while in use.					

Radio-frequency common mode – Test levels at ports for signal and control lines					
Frequency range (MHz)	Test Level (V/m)	Modulation Signal	Coupling Method	Steps	Performance Criteria
0.15 to 80	3	1kHz, 80%, AM, Sine wave	CDN	1%	A
Note: Only applicable to ports interfacing with cables whose total length, according to the manufacturer's specification, may exceed 3 m.					
Note 2: Change of state commands are not applied during the test.					

#### 4.8.4 EUT Configuration on Test

The configuration of the EUT is same as Section 3

#### 4.8.5 Test Procedure

- a) Set up the EUT, CDN and test generators as shown on Section 4.8.1
- b) Let the EUT work in test mode and measure it.
- c) The EUT are placed on an insulating support 0.1m high above a ground reference plane. CDN (coupling and decoupling device) is placed on the ground plane about 0.3m from EUT. Cables between CDN and EUT are as short as possible, and their height above the ground reference plane shall be between 30 and 50 mm (where possible).
- d) The disturbance signal described below is injected to EUT through CDN.
- e) The EUT operates within its operational mode(s) under intended climatic conditions after power on.
- f) The frequency range is swept from 150kHz to 80MHz using 3V signal level, and with the disturbance signal 80% amplitude modulated with a 1kHz sine wave.
- g) The rate of sweep shall not exceed  $1.5 \times 10^{-3}$  decades/s. Where the frequency is swept incrementally, the step size shall not exceed 1% of the start and thereafter 1% of the preceding frequency value.
- h) Recording the EUT operating situation during compliance testing and decide the EUT immunity criterion.

#### 4.8.6 Test Results: PASS

Please refer to the following page.

## Immunity to Conducted Disturbances, Induced by Radio-Frequency Fields Test Results

Standard	<input checked="" type="checkbox"/> EN 61547: 2009 <input checked="" type="checkbox"/> EN 61000-4-6: 2014+A1:2015		
Applicant	Fulton Science and Technology Lighting Co., Ltd		
EUT	LED TRI-PROOF LIGHT	Temperature	23.5℃
M/N	FLT-TPT-40L15	Humidity	53%
Test Mode	Lighting	Pressure	1008mbar
Input Voltage	AC 230V,50Hz	Test Results	Pass
Test Engineer	DEAN YA		

Line under test	Frequency range (MHz)	Test Level (V/m)	Coupling method	Performance Criteria
AC Power ports	0.15 to 80	3	CND	A
Signal/Control lines				
DC Input /Output Power ports				

**Remark:**

1.Modulation Signal:1kHz, 80%, AM, Sine wave.

2.Measurement Equipment:

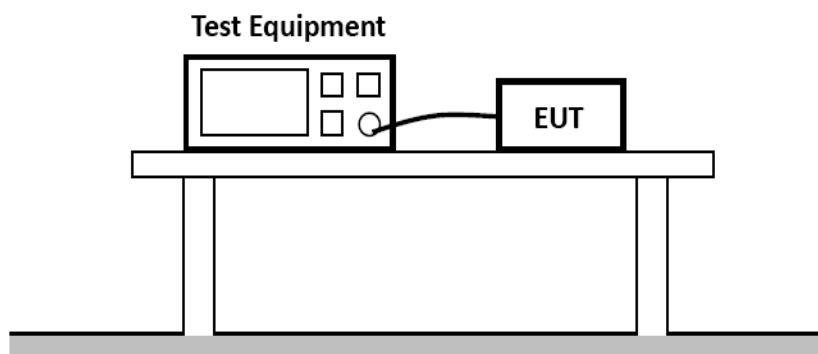
Simulator : CIT-10 (FRANKONIA)

CDN : ☐CDN-M2 (FRANKONIA)

☒CDN-M3 (FRANKONIA)

## 4.9 Surge Immunity Test

### 4.9.1 Block Diagram of Test Setup



### 4.9.2 Test Standard

EN 61547:2009

### 4.9.3 Limits

Surges – Test levels at input a.c. power ports					
Characteristics		Device			Performance Criteria
		Self-ballasted lamps and semi-luminaires	Luminaires and independent auxiliaries		
			Input power		
			≤25	>25 W	
Wave-shape data		1.2/50 μs	1.2/50 μs	1.2/50 μs	C
Test Levels	line to line	±0.5 kV	±0.5 kV	±1.0 kV	
	line to ground	±1.0 kV	±1.0 kV	±2.0 kV	
Note: In addition to the specified test level, all lower test levels as detailed in IEC 61000-4-5 should also be satisfied.					

Note: In addition to the specified test level, all lower test levels as detailed in IEC 61000-4-5 should also be satisfied.

### 4.9.4 EUT Configuration on Test

The configuration of the EUT is same as Section 3

#### **4.9.5 Test Procedure**

- a) Set up the EUT and test generator as shown on Section 4.9.1
- b) For line to line coupling mode, provide a 1.0KV 1.2/50us voltage surge (at open-circuit condition) and 8/20us current surge to EUT selected points.
- c) For line to earth coupling mode, provide a 2.0KV 1.2/50us voltage surge (at open-circuit condition) and 8/20us current surge to EUT selected points.
- d) At least 5 positive and 5 negative (polarity) tests with a maximum 1/min repetition rate are conducted during test.
- e) Different phase angles are done individually.
- f) Record the EUT operating situation during compliance test and decide the EUT immunity criterion for above each test.

#### **4.9.6 Test Results: PASS**

Please refer to the following page.

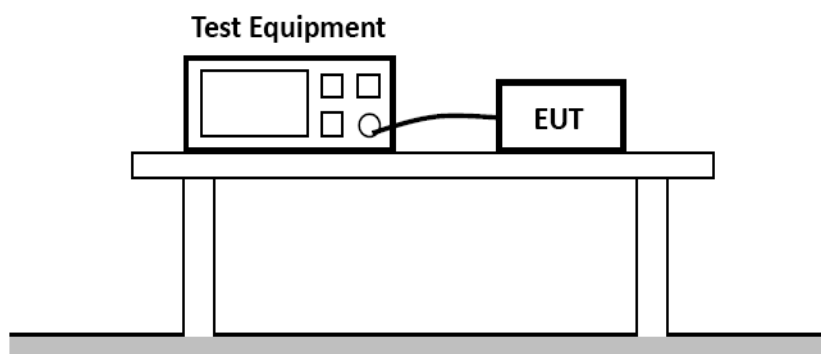
## Surge Immunity Test Results

Standard	☑ EN 61547: 2009                      ☑ EN 61000-4-5: 2014+A1:2017					
Applicant	Fulton Science and Technology Lighting Co., Ltd					
EUT	LED TRI-PROOF LIGHT			Temperature	23.5℃	
M/N	FLT-TPT-40L15			Humidity	53%	
Test Mode	Lighting			Pressure	1008mbar	
Input Voltage	AC 230V,50Hz			Test Results	Pass	
Test Engineer	DEAN YA					
Line under test	Tset Level (kV)	Polarity	Phase Angle	Number of surges	Repetition rate	Performance criteria
L-N	1.0	±	90°	10	1/min	C
	1.0	±	270°	10	1/min	C
L-PE	2.0	±	90°	10	1/min	C
	2.0	±	270°	10	1/min	C
N-PE	2.0	±	90°	10	1/min	C
	2.0	±	270°	10	1/min	C
L&N-PE	2.0	±	90°	10	1/min	C
	2.0	±	270°	10	1/min	C

Note:

## 4.10 Voltage Dips, Short Interruptions and Voltage Variations Immunity Test

### 4.10.1 Block Diagram of Test Setup



### 4.10.2 Test Standard

EN 61547:2009

### 4.10.3 Limits

Voltage dips and short interruptions-Test levels at input a.c. power ports			
	Test Level	Duration	Performance criterion
Voltage dips	70% of Vnom	10 cycle(50Hz)	C
Short Interruptions	0% of Vnom	0.5 cycle(50Hz)	B

### 4.10.4 EUT Configuration on Test

The configuration of the EUT is same as Section 3

### 4.10.5 Test Procedure

- Set up the EUT and test generator as shown on Section 4.10.1
- The interruptions is introduced at selected phase angles with specified duration.
- Record any degradation of performance.

### 4.10.6 Test Results: PASS

Please refer to the following page.

## Voltage Dips, Short Interruptions and Voltage Variations Immunity Test Results

Standard	☑ EN 61547: 2009                      ☑ EN 61000-4-11: 2004+A1:2017			
Applicant	Fulton Science and Technology Lighting Co., Ltd			
EUT	LED TRI-PROOF LIGHT	Temperature	23.5℃	
M/N	FLT-TPT-40L15	Humidity	53 %	
Test Mode	Lighting	Pressure	1008mbar	
Input Voltage	AC 230V,50Hz	Test Results	Pass	
Test Engineer	DEAN YA			
Vnom	Frequency	Test Level	Duration	Performance criteria
AC 230v	50Hz	70% of Vnom	10 cycle(50Hz)	C
AC 230v	50Hz	0% of Vnom	0.5 cycle(50Hz)	B

Note:

## 5. TEST PHOTOGRAPH

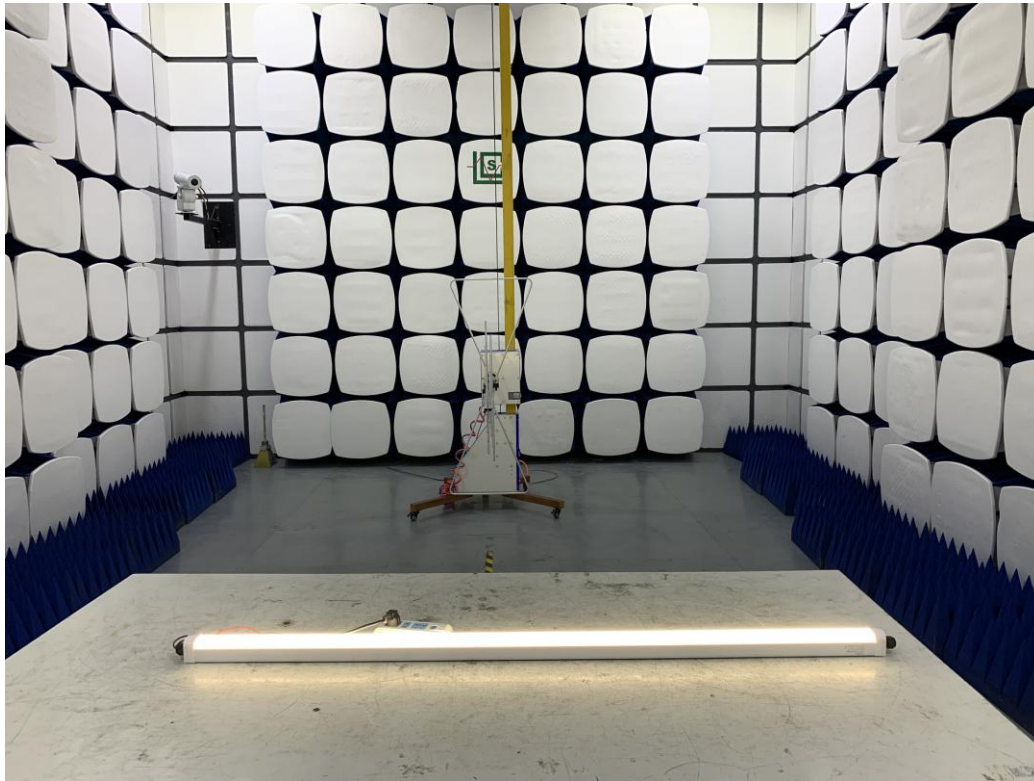
### 5.1 Photo of Conducted Disturbance at Mains Terminals



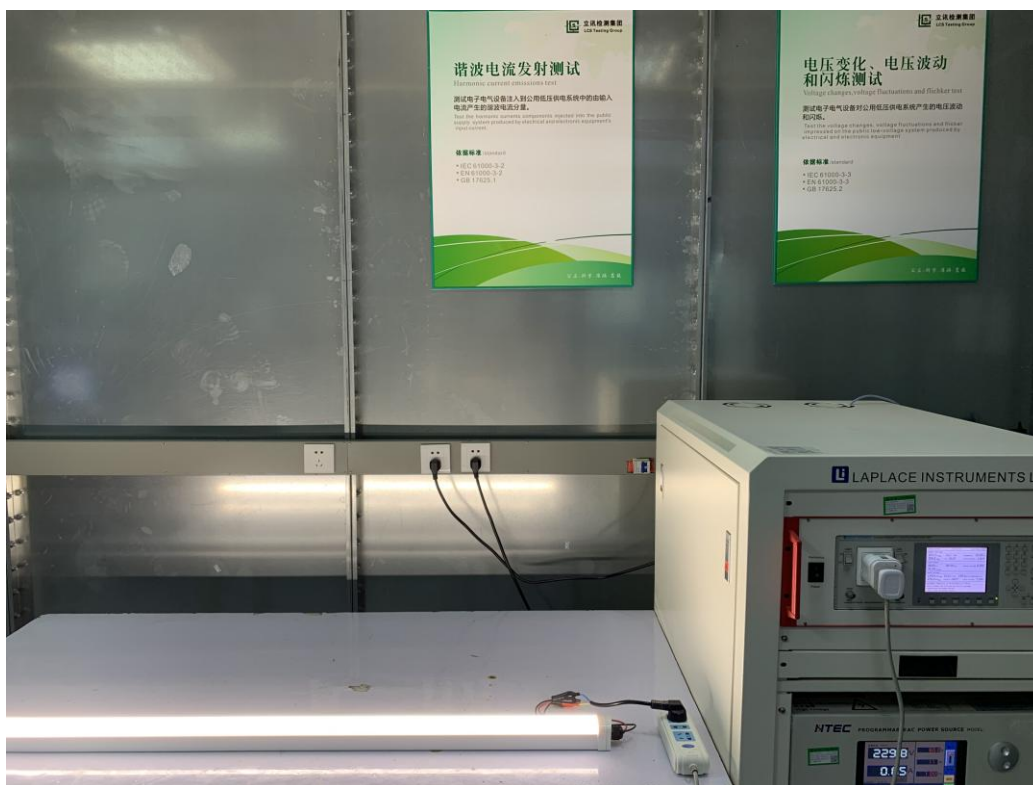
### 5.2 Photo of Radiated Disturbance(9kHz to 30MHz)



### 5.3 Photo of Radiated Disturbance(30MHz to 300MHz)



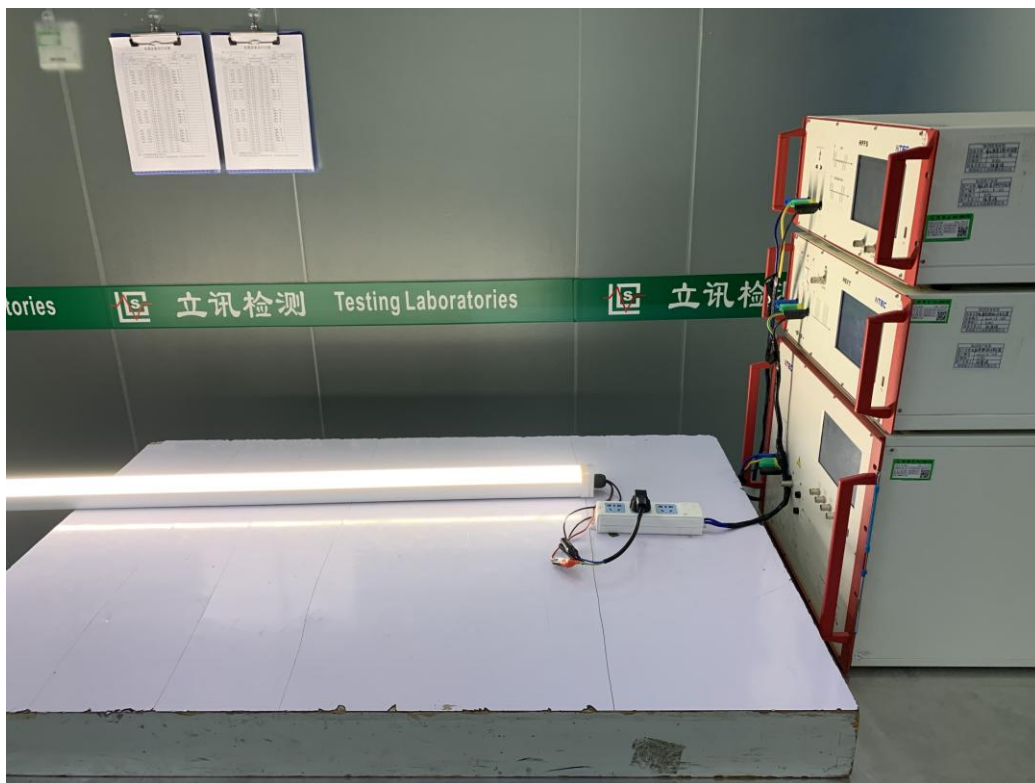
### 5.4 Photo of Harmonic Current Emissions



## 5.5 Photo of Electrostatic Discharge Immunity Test



## 5.6 Photo of Electrical Fast Transient/Burst Immunity Test



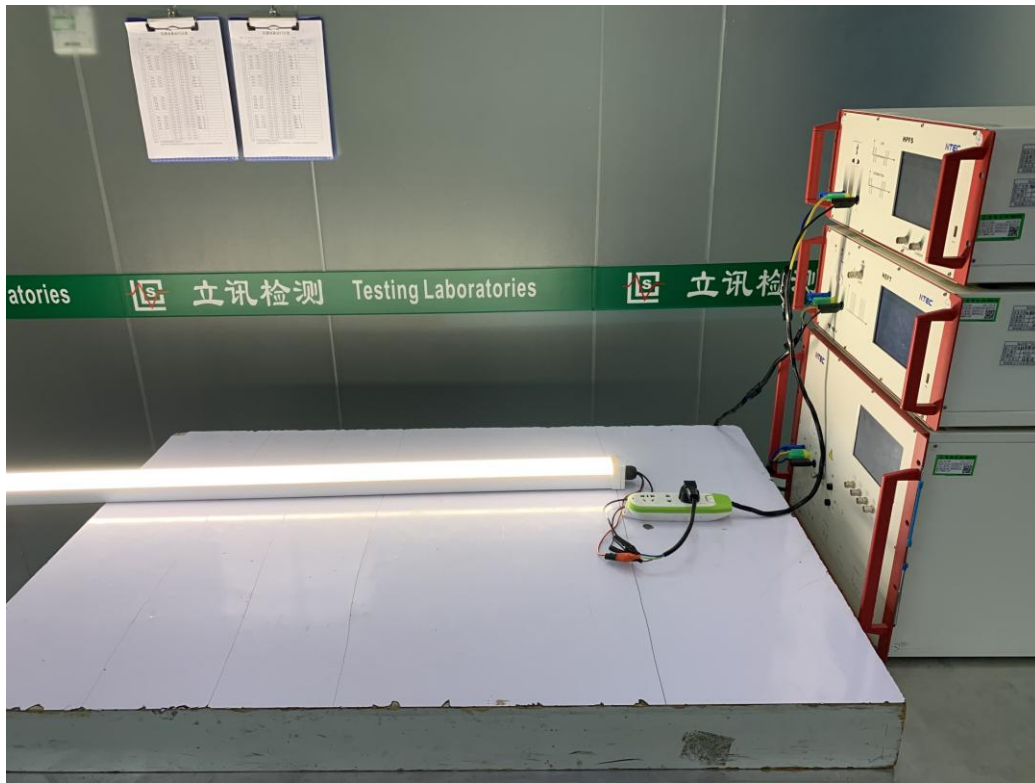
## 5.7 Photo of Immunity To Conducted Disturbances, Induced by Radio-Frequency Fields



## 5.8 Photo of Surge Immunity Test



## 5.9 Photo of Voltage Dips,Short Interruptions and Voltage Variations Immunity Test



## 6. EXTERNAL AND INTERNAL PHOTOS OF THE EUT

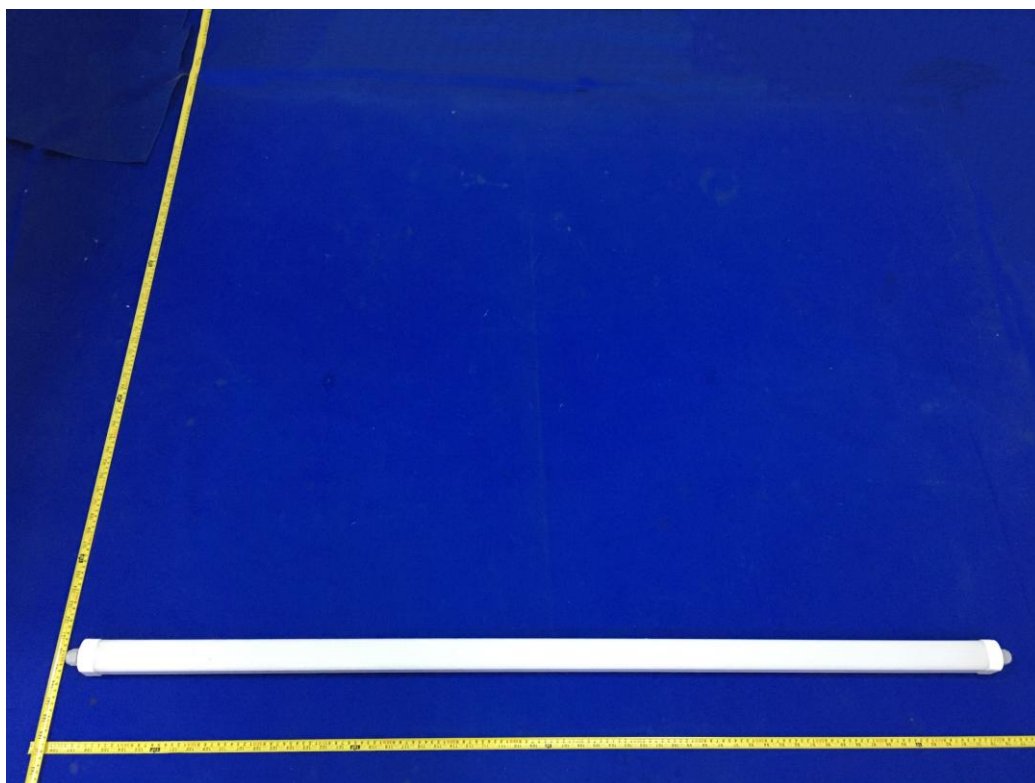


Figure. 1

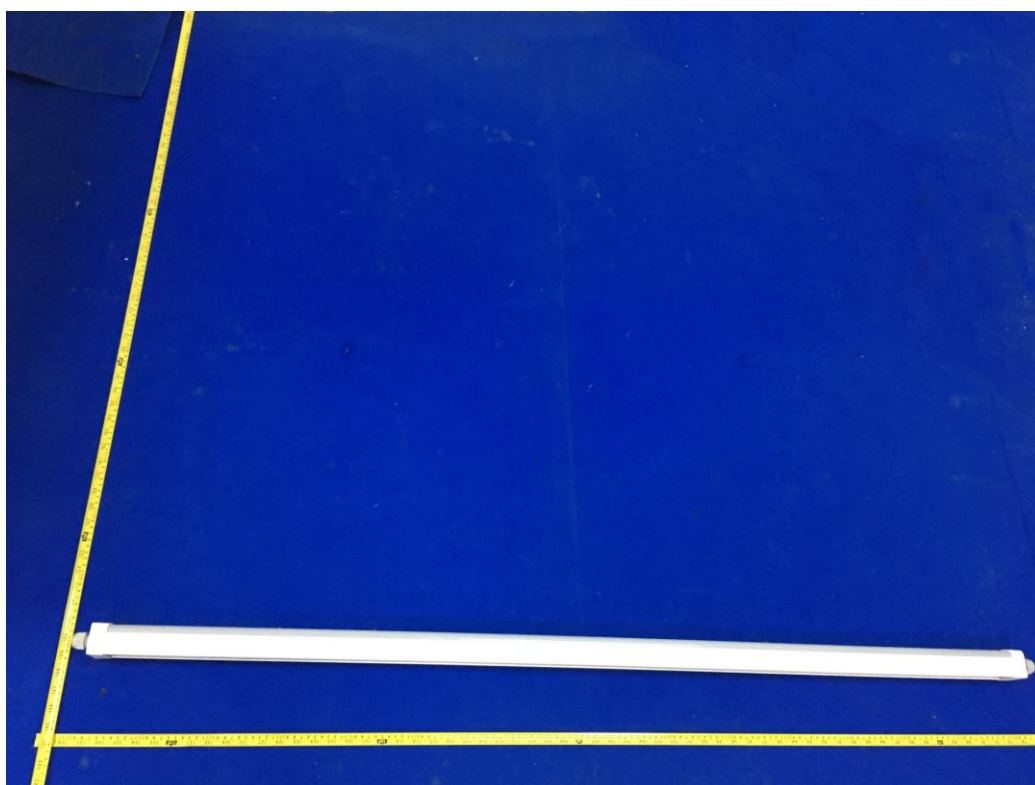


Figure. 2

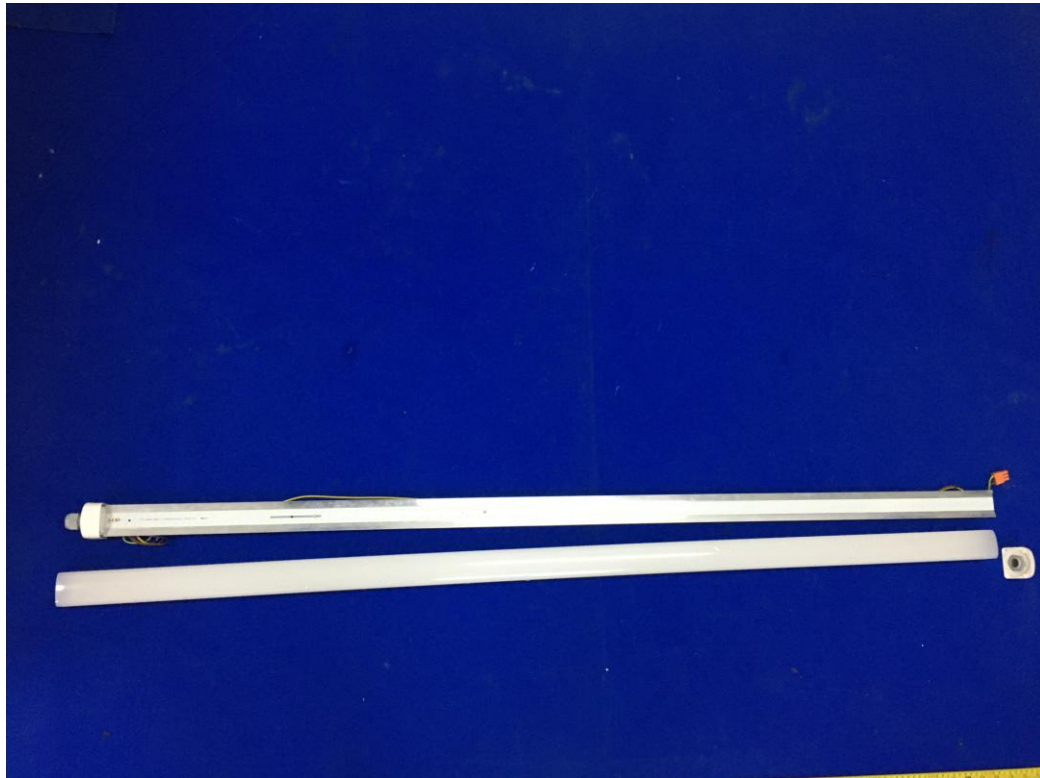


Figure. 3

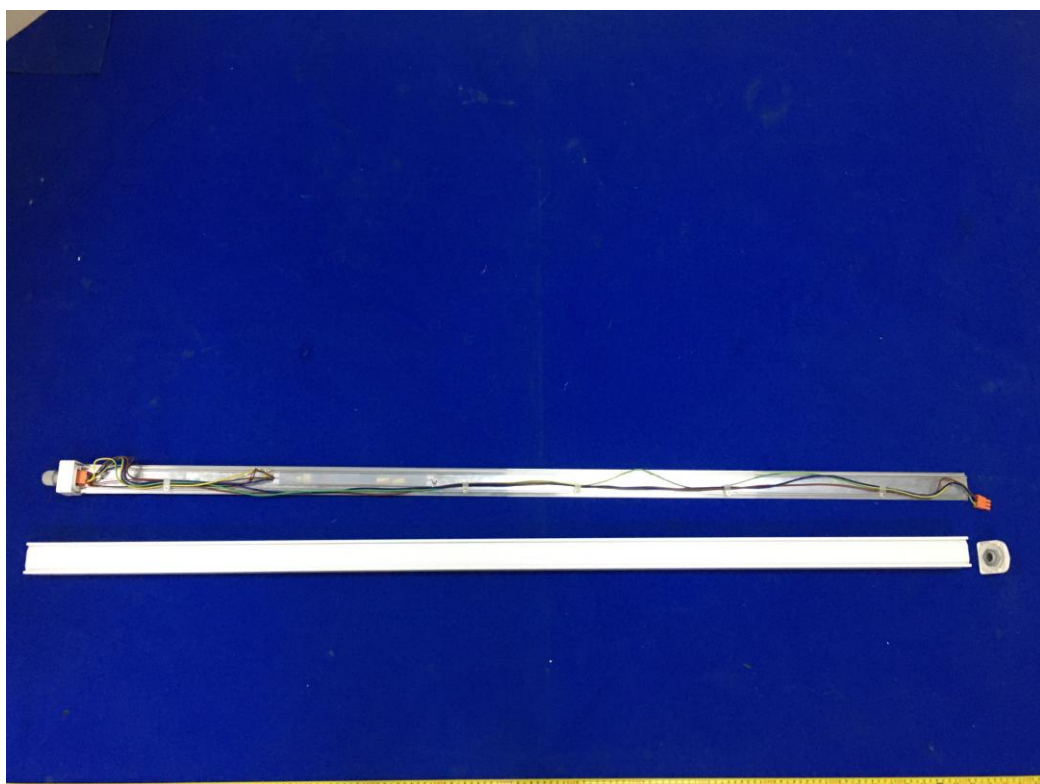


Figure. 4

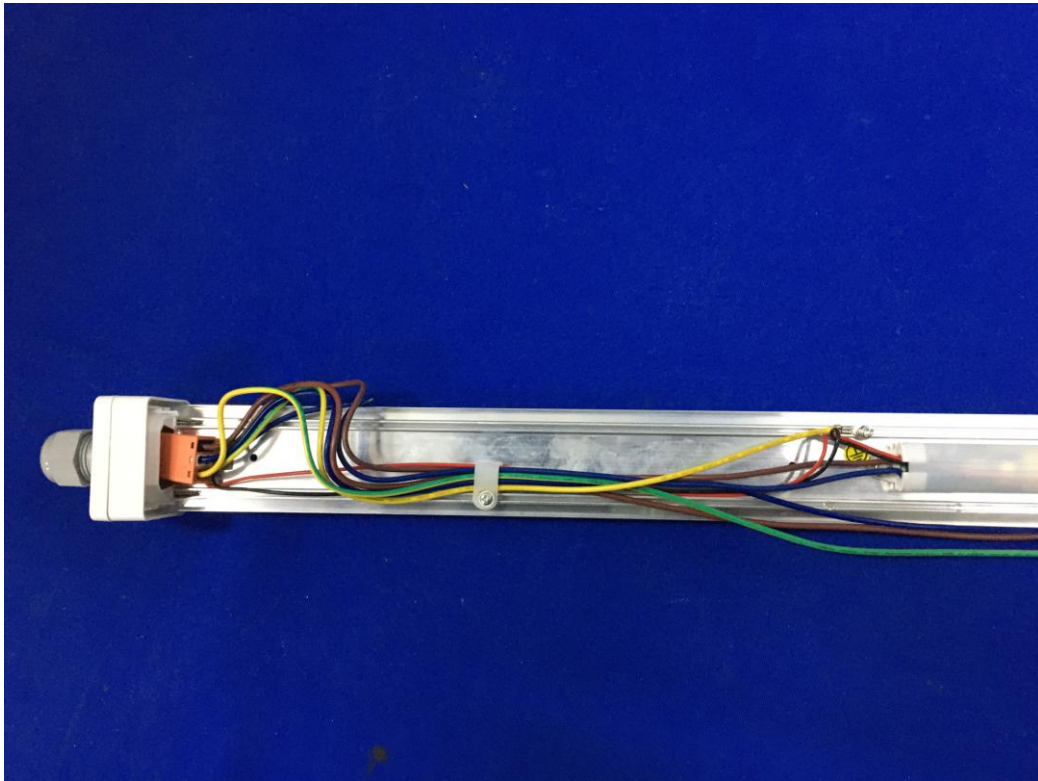


Figure. 5

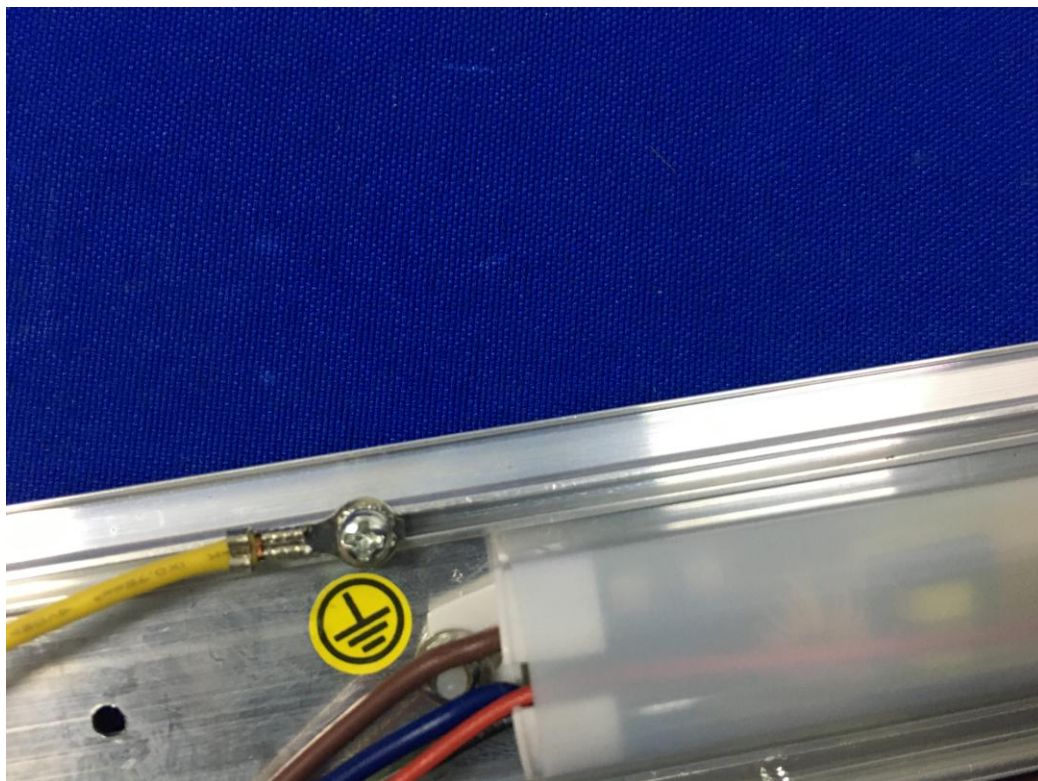


Figure. 6

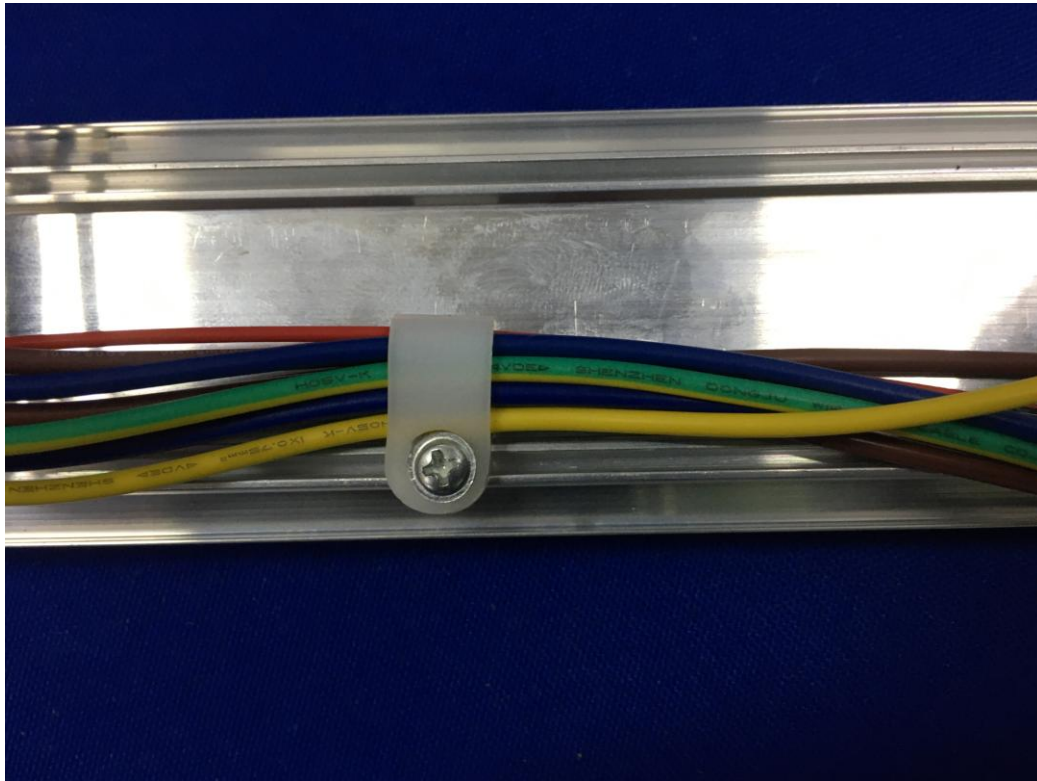


Figure. 6

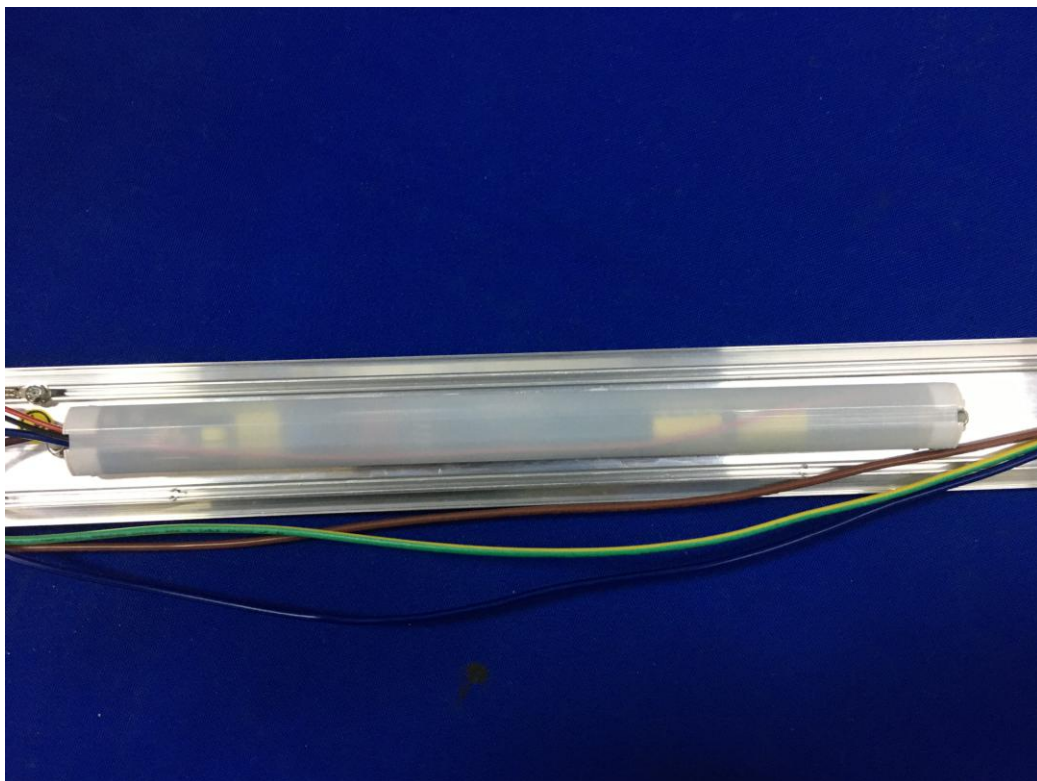


Figure. 7



Figure. 8



Figure. 9

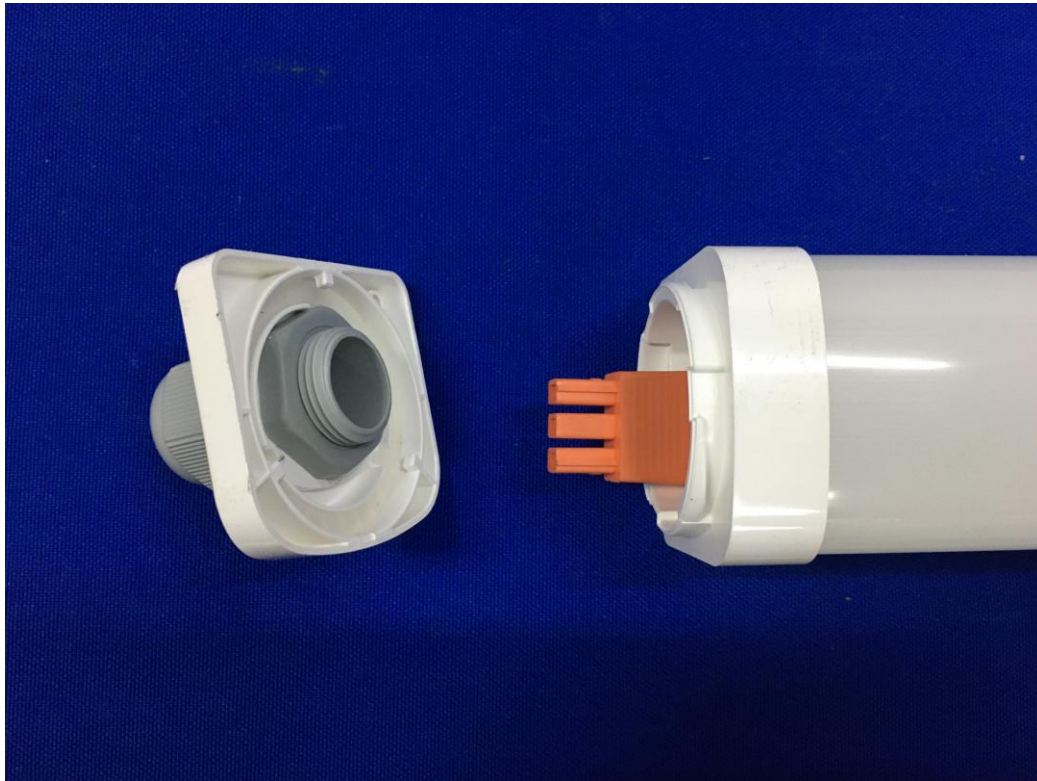


Figure. 10

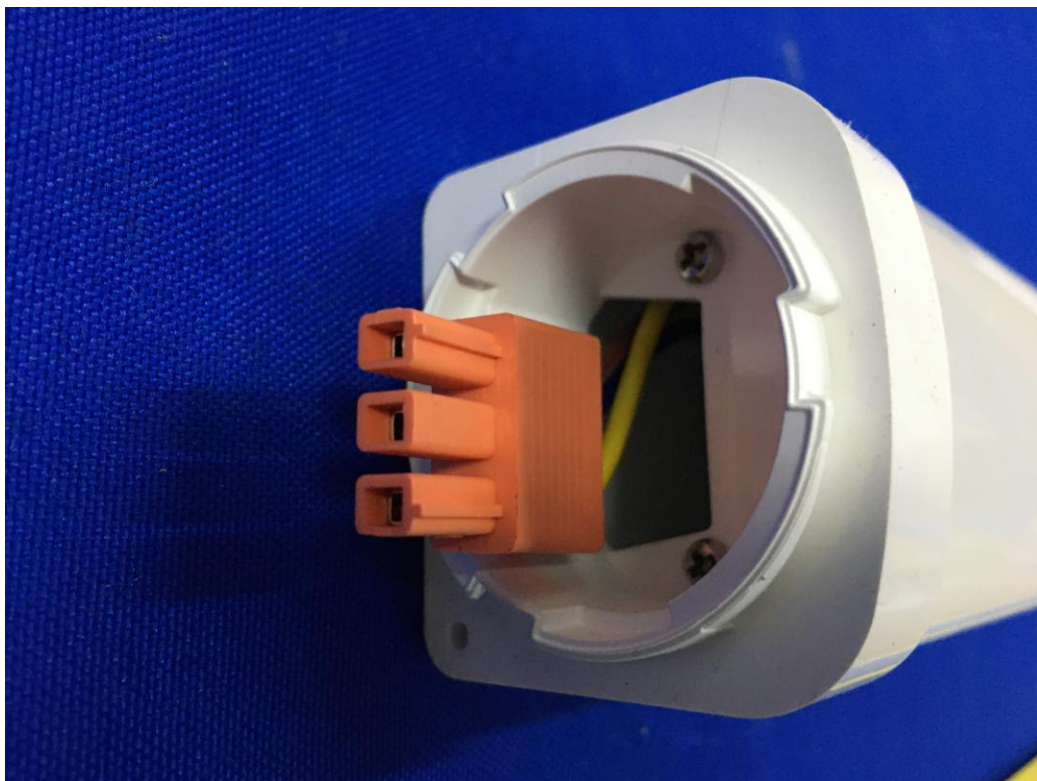


Figure. 11

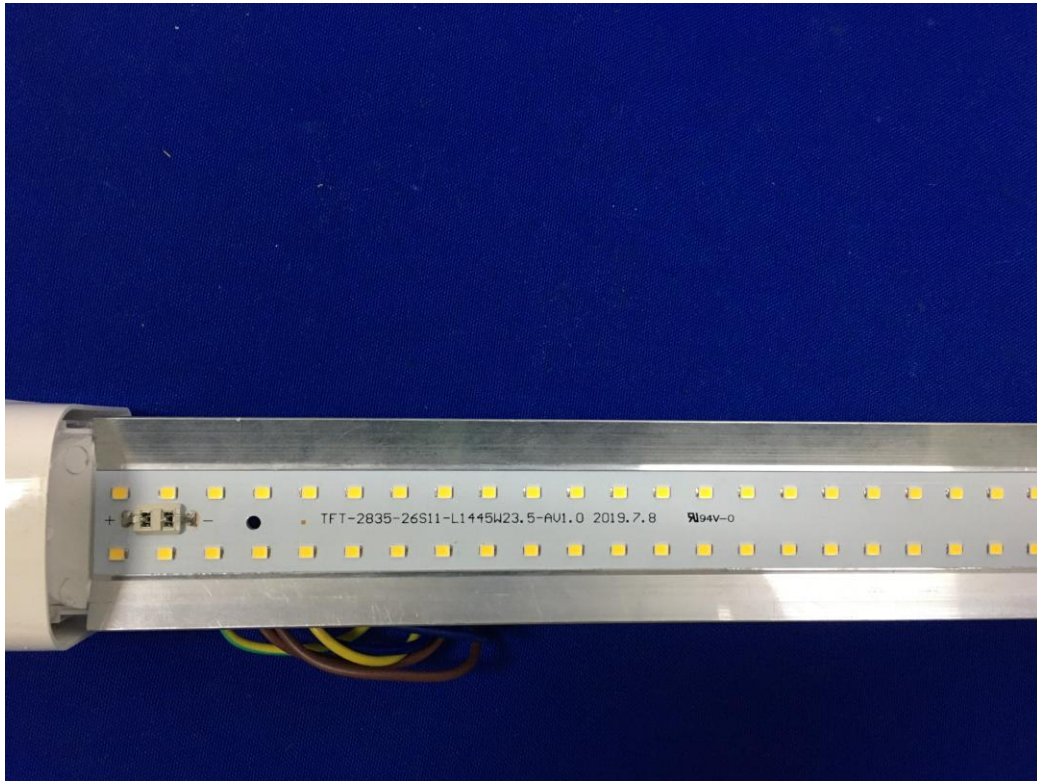


Figure. 12

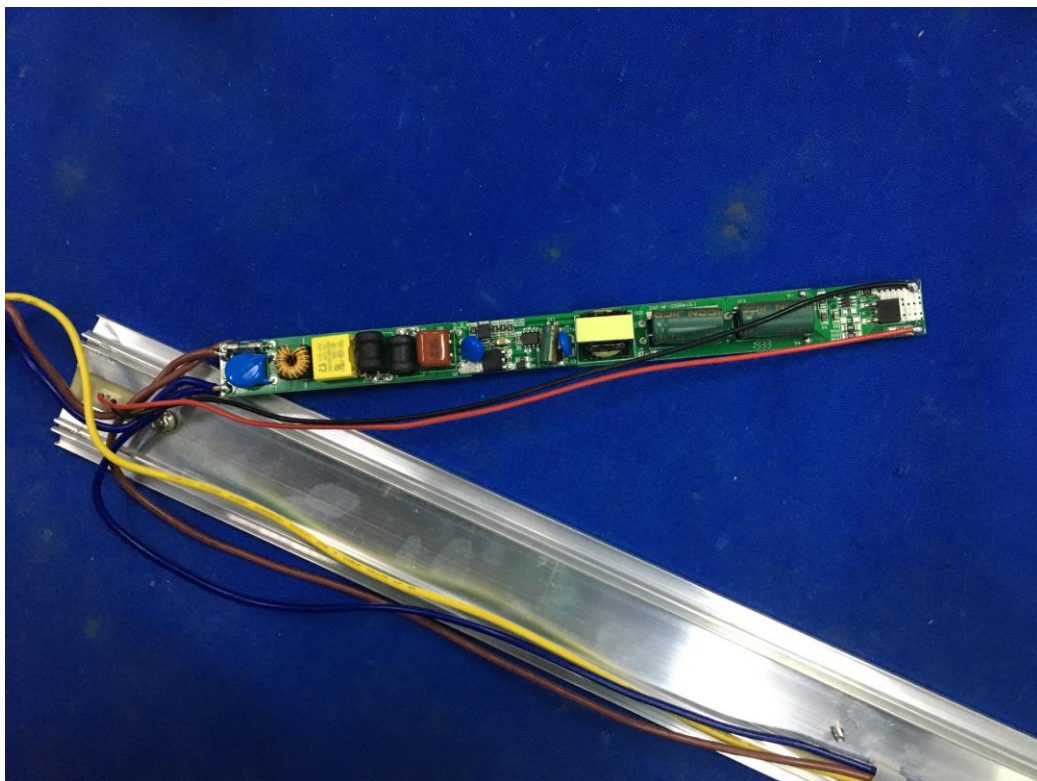


Figure. 13

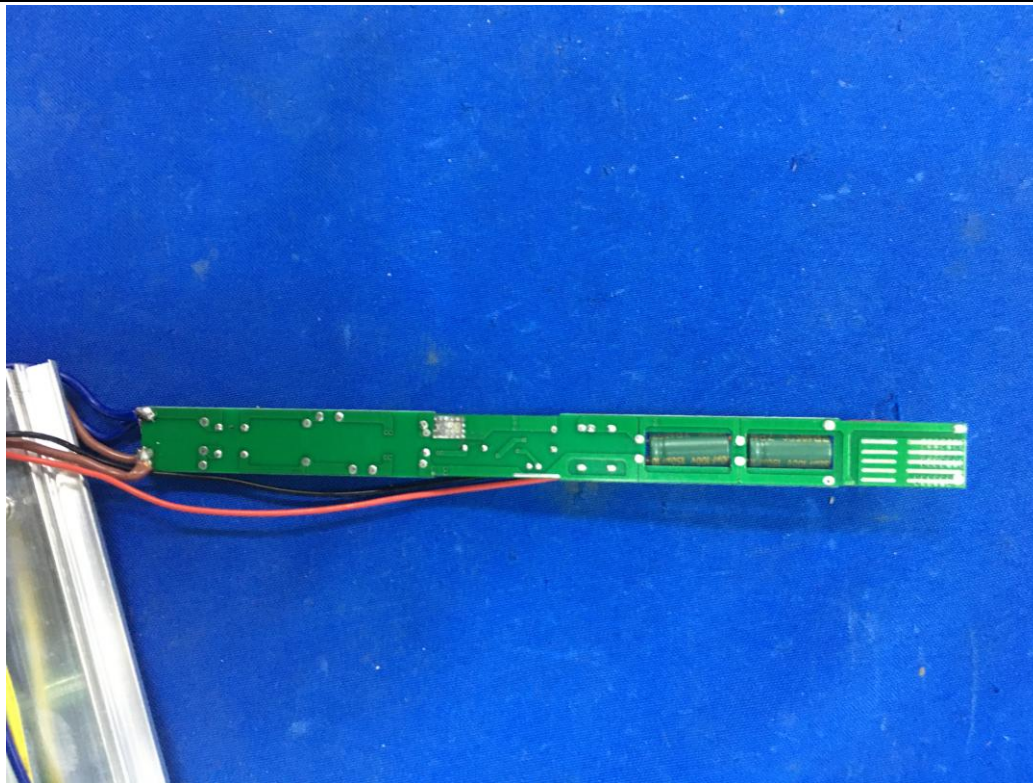


Figure. 14

-----THE END OF TEST REPORT-----